

2024 KOR-EU Joint Workshop

Large-Scale Synthesis of 2-Dimensional Transition Metal Dichalcogenide (TMDCs) by Low-Temperature Plasma and their Applications

Taesung Kim

School of Mechanical Engineering and SAINT
Department of Semiconductor Convergence Engineering
Sungkyunkwan University (SKKU)

Prof. Taesung Kim

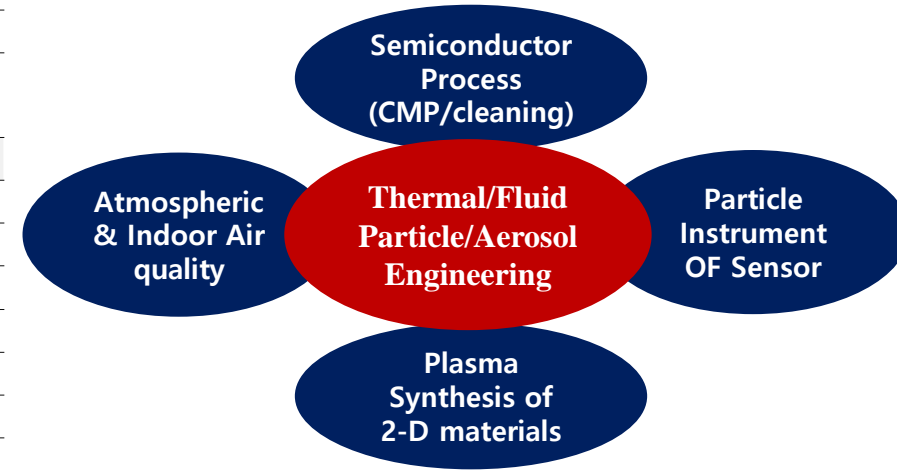


Education

Year	Degree	Institute	Major
2002	Ph. D.	U. of Minnesota, Twin Cities	Mechanical Engineering
1998	M. S.	U. of Minnesota, Twin Cities	Mechanical Engineering
1994	B. S.	Seoul National University	Mechanical Engineering

Work experience

Period	Institute/Company	Rank
2005. 3 - present	SKKU School of Mechanical Engineering	Professor
2023. 1 - present	SKKU College of Engineering	Dean
2019. 1 - 2020.12	SKKU Admissions Office	Vice President
2014. 3 - 2018. 12	SKKU Business Foundation	Vice President
2011. 10 - 2015. 4	Samsung Display	Technical Advisor
2002. 3 - 2005. 2	Seagate Technology, USA	Senior/Staff Engineer
1994. 3 - 1996. 6	ROK Army	2 nd /1 st Lieutenant



Graduate Student

Semiconductor Process



2D Materials and application



Aerosol Technology & Machine Learning



Research Professor
Dr. Keunseok H. Kim



Post Doc.
Dr. Vinit Kanade

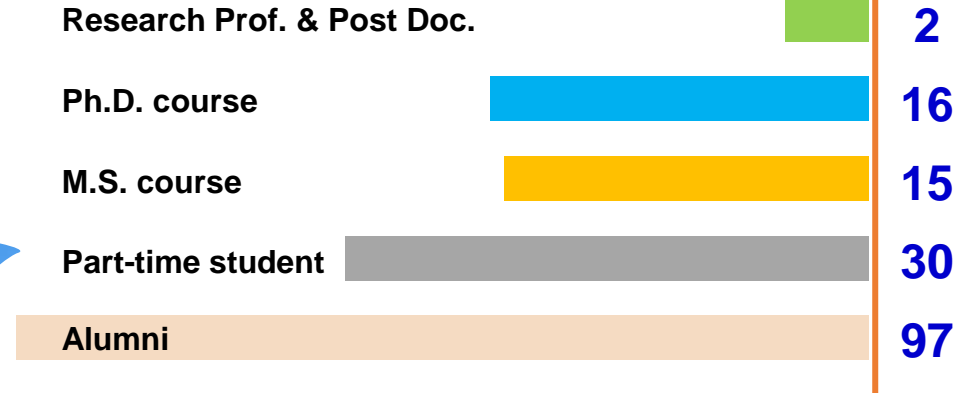


Research Group

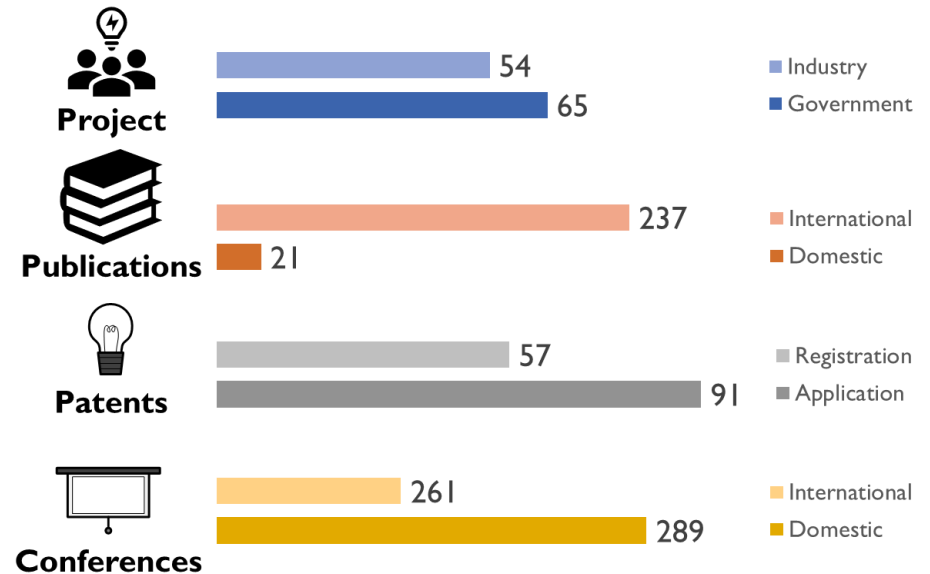


xy Note20 5G

Members

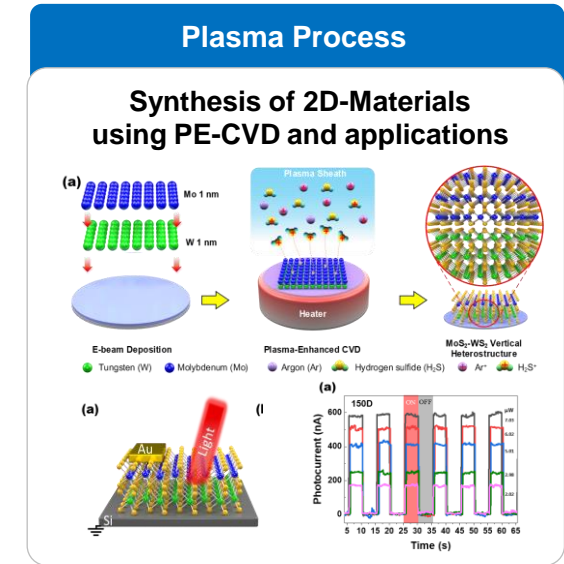
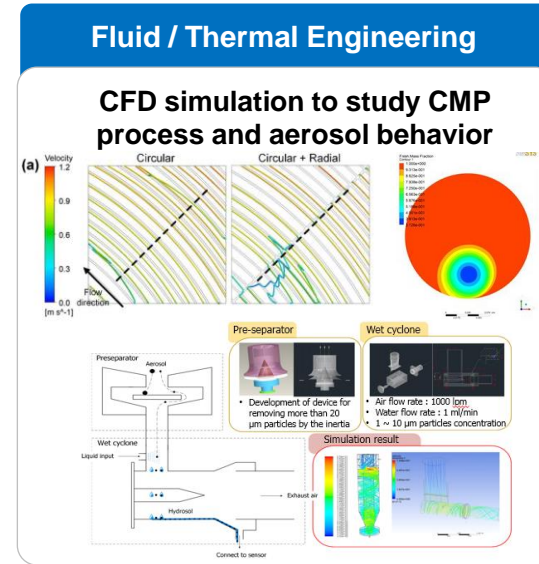
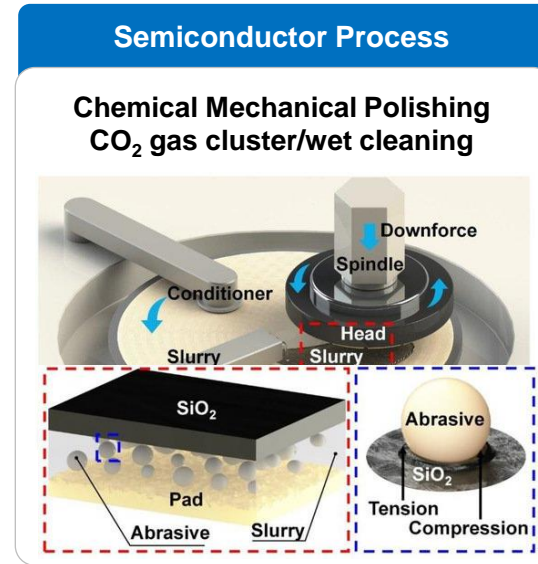
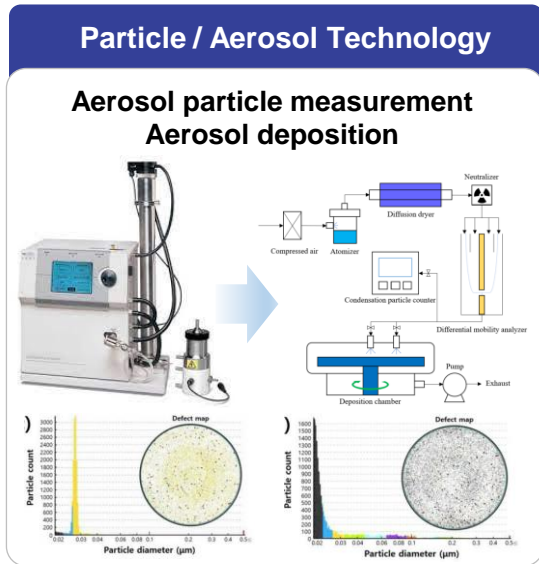


Achievements



Nano Particle Technology Lab.

Research Area



Collaboration Partners



Univ.	서울대학교	포항공과대학교	중앙대학교	가천대학교	Universita Campus Bio Medico (Italy)	상하이 대학교 (China)	심바이오시스 국제 대학교 (India)					
Research Institute	한국기계연구원	한국표준과학연구원	한국생산기술연구원	한국철도기술연구원	한국철도기술연구원	한국철도기술연구원	한국철도기술연구원					
Industry	삼성전자	삼성디스플레이	삼성SDI	SK 하이닉스	SKC	SK siltron	현대자동차	Wonik IPS	3M	Merck	KPX Chemical	SEMES

Part 1. TMDC Research in NPTL

- 1-1. Advantage of PECVD-based 2D Material Synthesis
- 1-2. History of 2D Material Synthesis in Our Group

Part 2. Two-dimensional Transition Metal Dichalcogenide Materials

- 2-1. Trends in Two-Dimensional Materials Research
- 2-2. Types and Characteristics of Two-Dimensional Materials
- 2-3. Synthesis Methods and Limitations of Two-Dimensional Materials
- 2-4. Potential to Overcome Limitations of 2-D material synthesis via Plasma-assisted Processes
- 2-5. Advantages of Synthesizing 2D Materials using Low-Temperature Plasma Technology
- 2-6. 2D Material Synthesis Technology via Low-Temperature Plasma

Part 3. Electronic Applications - Tunneling device

- 3-1. Need for Next Generation Devices
- 3-2. Next-Generation Device Application Based on 2D Materials
- 3-3. One-Step MoS₂-WS₂ Vertical HT Using Penetrative H₂S Plasma
- 3-4. Negative differential resistance (NDR) photodetector using MoS₂/p-Si HT
- 3-6. TMDC Layer Phase Transition via Process Temperature Control
- 3-7. Enhancement of the NDR Performance via Phase Transition

Part 4. Electronic Application – Neuromorphic device

- 4-1. Mechanism of Neuromorphic Device
- 4-2. 2D Materials for Neuromorphic Applications
- 4-3. Grain Confinement via Low-temperature Synthesis
- 4-4. Nanograin Memristor
- 4-5. Grain Boundary Effect in Neuromorphic Performance Reliability
- 4-6. Patents

1-1. Advantage of PECVD-based 2D Material Synthesis

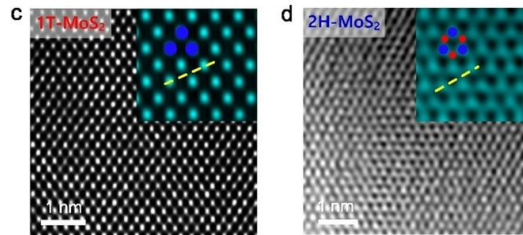
Plasma Enhanced Chemical Vapor Deposition (PECVD) is a widely used technique in various industries, including semiconductors, optics, and nanotechnology.

- Lower Temperature Processing (< 300°C)
- Controlled Film Properties
- Compatibility with various Substrates
- Uniform and Large-scale Films

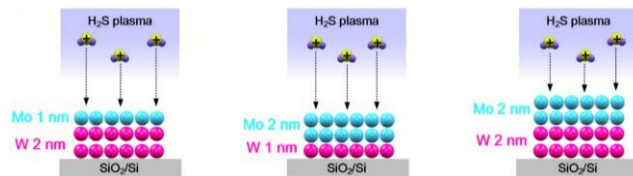
- Enhanced Chemical Reactions
- Industrial Compatibility
- Customization



Phase Controlled Synthesis



One-step heterostructure Synthesis



Heterostructure Synthesis

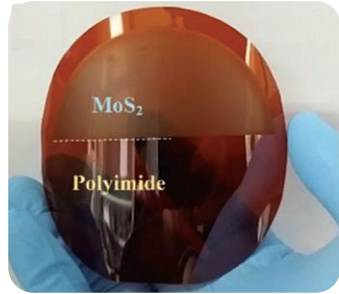
Wafer Scale and Uniform thin film on Different Substrate



4-inch Substrate

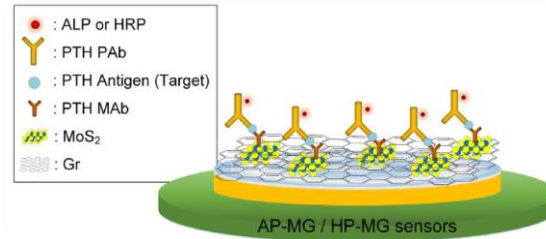


1-1. History of 2D Material Research

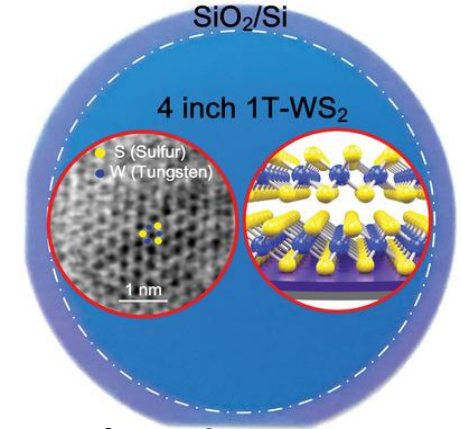


Dr. Chisung Ahn
KITECH (Korea Institute of Industrial Technology)

MoS₂-Graphene Hormone Sensor On PCB (2016) *Scientific Reports*



Dr. Vinit Kanade
NPTL, Sungkyunkwan University

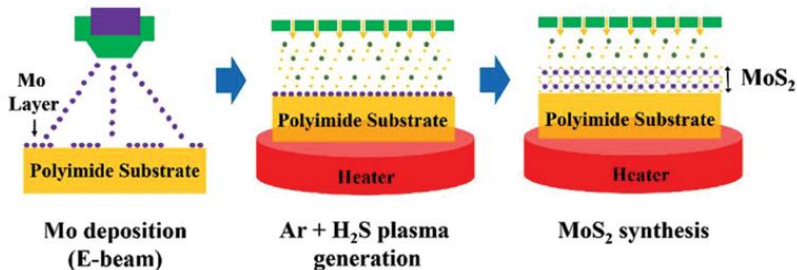


Wafer-Scale 1T-WS₂ (2020) *Small*

2015



The First Plasma-Based TMDC Synthesis

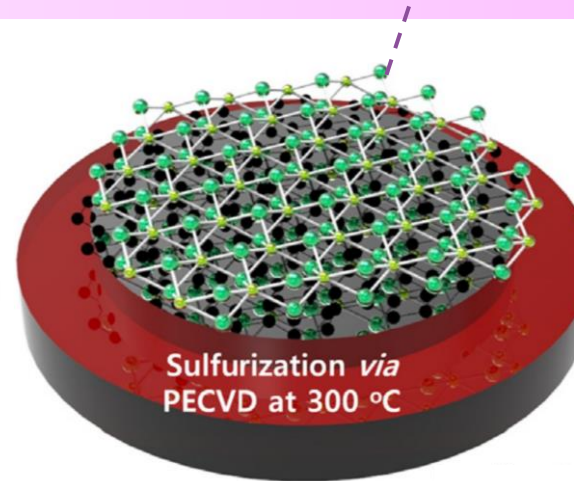


Low-Temperature Synthesis of Large-Scale MoS₂ on Polyimide (2015) *Advanced Materials*



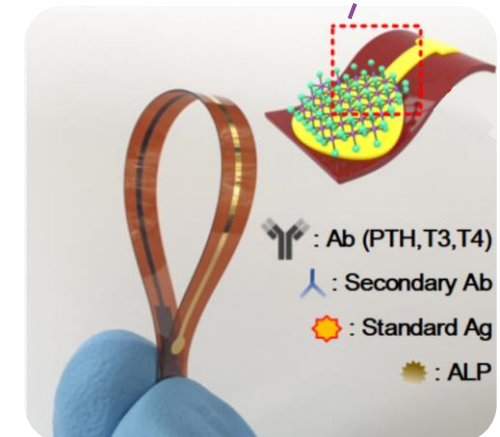
Dr. Hyeong-U Kim
KIMM (Korea Institute of Machinery & Materials)

- S
- Mo
- C



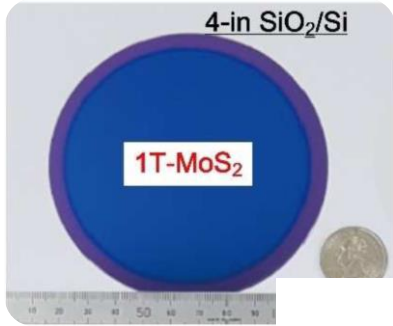
Wafer-Scale MoS₂ / Graphene (2018) *Applied Surface Science*

Flexible Endocrine Sensor (2020) *Analytical Chemistry*



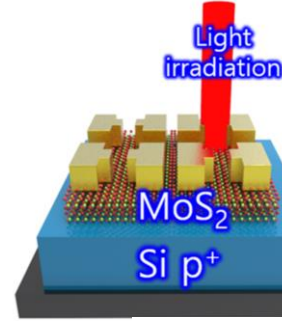
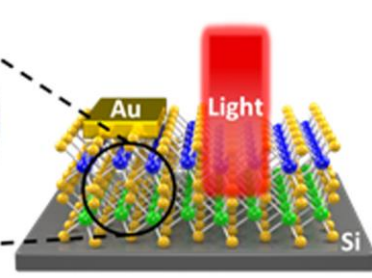
Part 1. TMDC Research in NPTL

Wafer-scale 1T MoS₂ for HER reaction
(2021) *ChemSusChem*



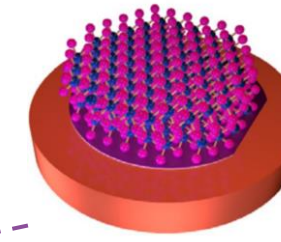
Dr. Chaitanya Kanade
Centre for Materials for Electronic
Technology, Pune (C-MET, Pune)

Photodetector Device by Plasma synthesized TMD
(2021) *ChemSusChem*, (2021), *ACS Applied Materials & Interfaces*



Gunhoo Woo (Ph.D. student)
NPTL, SKKU

Multiphase MoS₂ Heterostructure for
Photodetector (2023) *Nanoscale*



1T/2H-MoS₂
heterostructure



Kubra Aidin (Ph.D. student)
NPTL, SKKU

2021

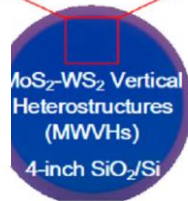
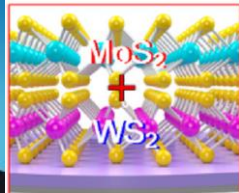
2022

2023

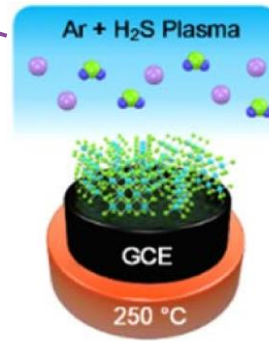
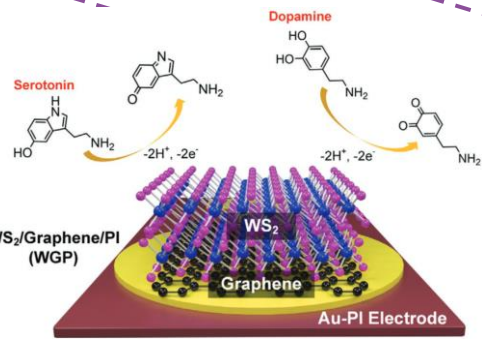
2024 ~



Hyunho Seok
(Ph.D. student)
NPTL, SKKU

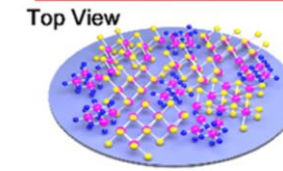
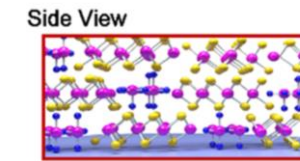


Wafer-scale Vertical Heterostructure of MoS₂/WS₂
WS₂/Graphene/PI
(WGP)
Au-PI Electrode
(2021) *Small*



Vertically Aligned TaS₂ for HER
(2022) *Nanotechnology*

Patchwork-Structured 1T-WS₂/a-WO₃
(2022) *ACS Applied Materials & Interfaces*



Nanograin
1T-WS₂/ a-WO₃



Jinil Cho (Ph.D. student)
NPTL, SKKU

Part 2. Two-dimensional Transition Metal Dichalcogenide Materials

2-1. Trends in Two-Dimensional Materials Research

2-2. Types and Characteristics of Two-Dimensional Materials

2-3. Synthesis Methods and Limitations of Two-Dimensional Materials

2-4. Potential to Overcome Limitations of 2-D material synthesis via Plasma-assisted Processes

2-5. Advantages of Synthesizing 2D Materials using Low-Temperature Plasma Technology

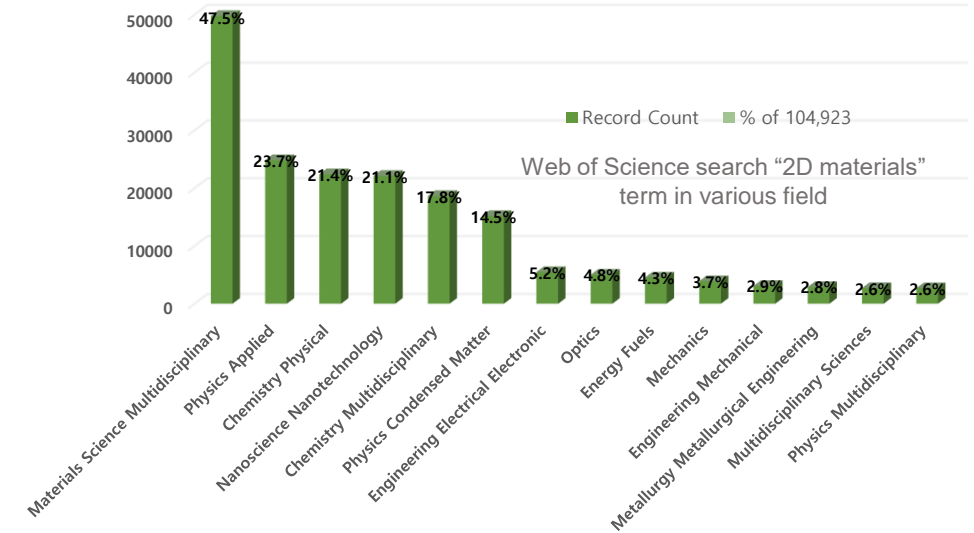
2-6. 2D Material Synthesis Technology via Low-Temperature Plasma

Part 2. Two-dimensional Transition Metal Dichalcogenide Materials

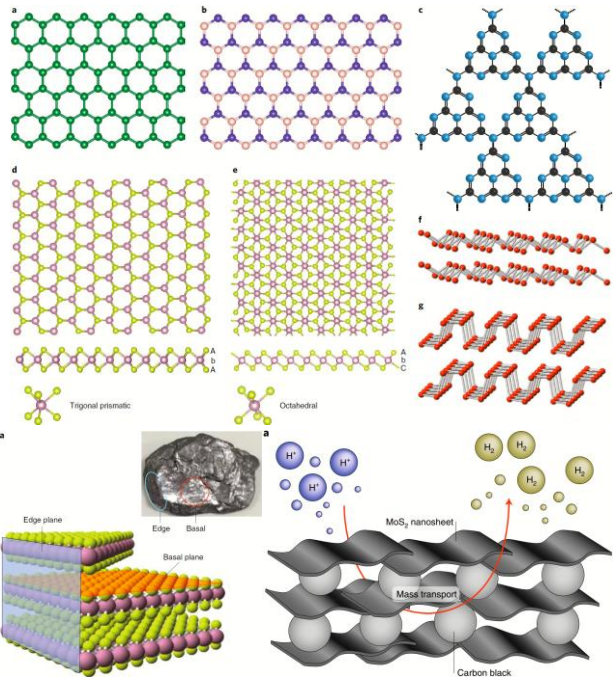
2-1. Trends in Two-Dimensional Materials Research

2D materials, often exhibit different physical behaviors compared to their 3D counterparts due to **quantum confinement**.

- High Surface Area
- Electrical Properties
- Thermal Conductivity
- Quantum Effects
- Optical Properties
- Chemical Reactivity
- Bandgap Tunability
- Mechanical Strength



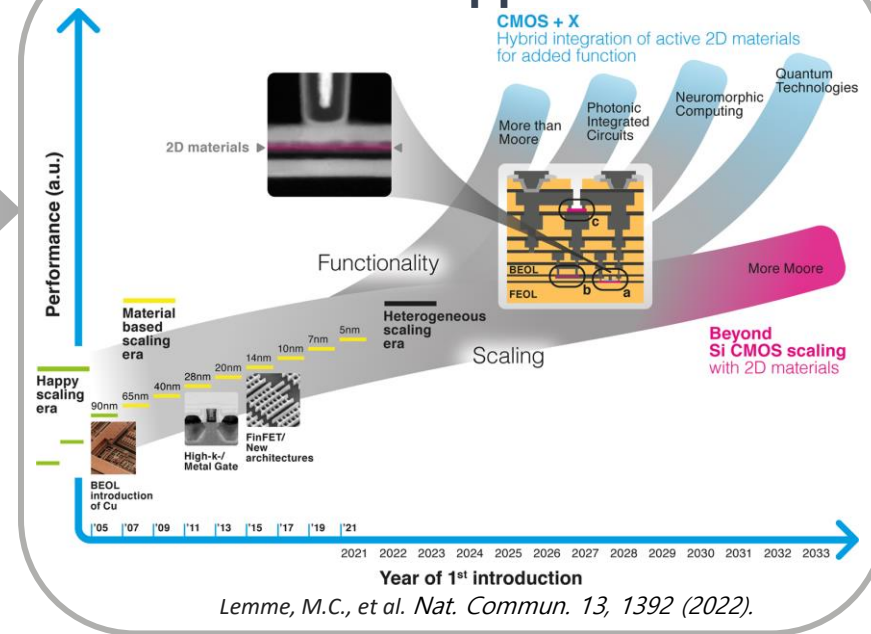
Catalytic Application



Challenges

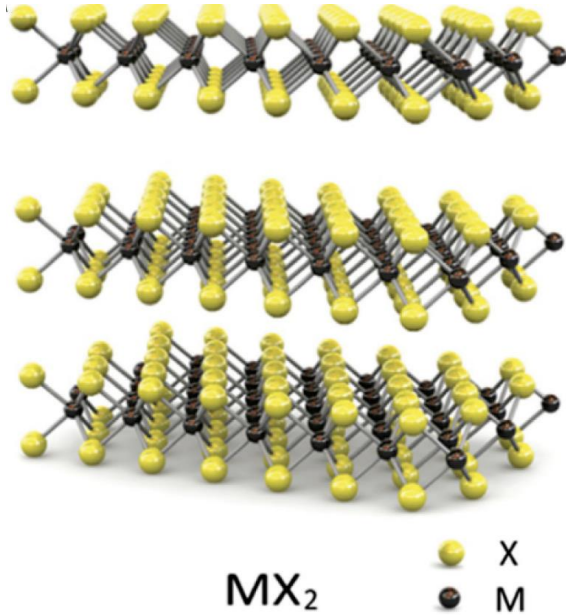
- Large-scale production
- Integration into existing technologies
- Technology Readiness Level (TRL)

Electrical Application



Lemme, M.C., et al. *Nat. Commun.* 13, 1392 (2022).

2-2. Types and Characteristics of TMDC Materials



- Due to strong in-plane covalent bonds, it exhibits **high physical and chemical stability along with excellent mechanical flexibility**
- The presence of the '**quantum confinement effect**' results in properties such as band gap being **different from those in three-dimensional structures** due to discrete energy states.
- A two-dimensional structure composed of one transition metal (M) and two chalcogen elements (X: S, Se, Te) bonded together

(MX_2 : MoS_2 , WS_2 , $PdSe_2$, WTe_2 ...)

H																	He
Li	Be											B	C	N	O	F	Ne
Na	Mg	3	4	5	6	7	8	9	10	11	12	Al	Si	P	S	Cl	Ar
K	Ca	Sc	Ti	V	Cr	Mn	Fe	Co	Ni	Cu	Zn	Ga	Ge	As	Se	Br	Kr
Rb	Sr	Y	Zr	Nb	Mo	Tc	Ru	Rh	Pd	Ag	Cd	In	Sn	Sb	Te	I	Xe
Cs	Ba	La-Lu	Hf	Ta	W	Re	Os	Ir	Pt	Au	Hg	Tl	Pb	Bi	Po	At	Rn
Fr	Ra	Ac-Lr	Rf	Db	Sg	Bh	Hs	Mt	Ds	Rg	Cn	Uut	Fl	Uup	Lv	Uus	Uuo

Nature chemistry, 2013, 5.4: 263-275.

- Due to its excellent mechanical properties, it can be applied to flexible substrates, and its atomic-scale structure plays **a crucial role in enhancing circuit integration**
- Promising as a building block for next-generation electronic devices**, thanks to its structural stability, high electron mobility, and direct bandgap characteristics

2-3. Synthesis Methods and Limitations of Two-Dimensional Materials

Mechanical delamination method

Micro-Mechanical Cleavage

Wang, X. Y., et al. *Nature reviews chemistry*, 2018

Low productivity and difficulty in size control

Synthesis of 2D Materials through CVD

Manzeli, S., et al. *Nature Reviews Materials* 2.8 (2017): 17033

Tummala P., et al. *Materials* 2020, 13, 2786

High Process Temperatures and Non-Uniform Thin Film Formation

Chemical delamination method

Zhang, W., et al. *Nanoscale*, 2015,7, 18364-18378

Difficulty in achieving consistent reproducibility due to uneven manufacturing

Synthesis of 2D Materials through PVD

Lu W., et al. *Appl. Surf. Sci.*, 2020, 532, 147461

Defect Formation Due to High Energy

MoS₂ Nanosheet

Top-down Method

Bottom-up Method

Vishnoi P., *Chemistry A European Journal*, 2016

2-4. Potential to Overcome Limitations of 2-D material synthesis via Plasma-assisted Processes

Limitations of 2-D Material Synthesis Processes

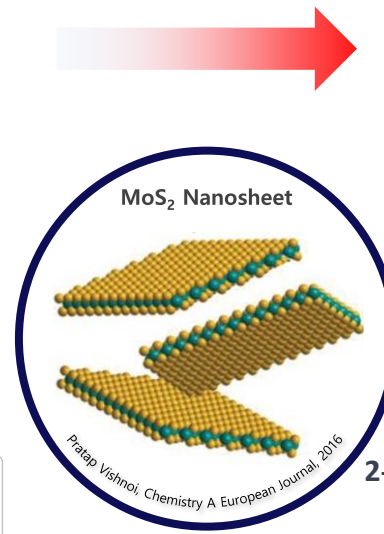
Alternative Processes and Outstanding Challenges

MOCVD	ALD	Laser-CVD
Organic Metal Gases	Atomic Layer Deposition	Nucleation via Patterning
Above 350 °C	Below 350 °C	Above 600 °C
Anticipated Low Yield as a Nucleation-Driven Growth Process	Slow Synthesis Speed Due to Stepwise Processing	Multi-Process and Limited Partial Synthesis

Sebastian, A., et al. *Nat. Commun.* (2021) 12, 693

Lau, C. S., et al. *Adv. Mater.* (2021) 2103907

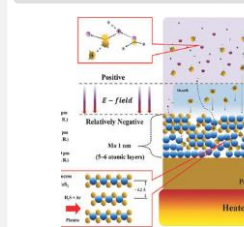
Li, J., et al. *Nature* (2020) 579, 368



Addressing Challenges Through Plasma Processing Tech

Characteristics and Benefits of Low-Temperature Plasma Processing

Schematic of Low-Temperature



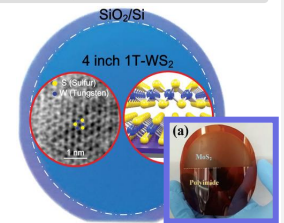
Adv. Mater. (2015) 27, 5223-5229.

Bottom-Up Approach for Crystalline Formation Induced by Ion Activation Species

Low-temp : 150-300 °C

Large-Area Deposition and Synthesis Possible Through Plasma Processing

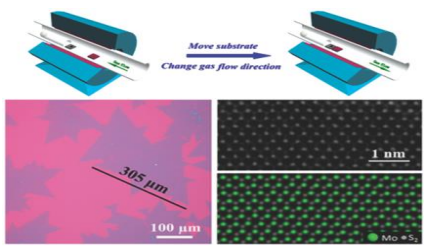
Large-Area Synthesis



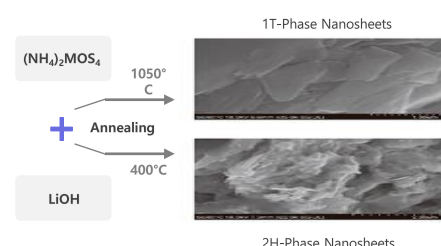
Small (2020), 16, 1905000.

Absence of 2-D Material Property Control Techniques

01 Nanocrystal Control Technology Needed for High Ion Mobility



02 The Challenge of Large-Area and formation of Heterointerfaces



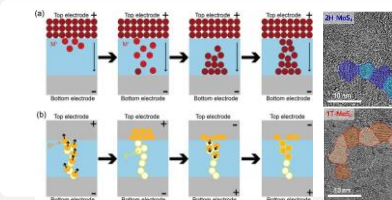
Chen, J., et al. *Adv. Sci.*, (2016). 3, 1600033. Li, Y., et al. *ACS Appl. Energy Mater.* 2020, 3, 1, 998-1009

- Traditional high-temperature processes only allow for the synthesis of high-crystalline/single-crystalline materials
- Additional Processes Required for Material Process Property Control

Feasibility of 2-D Material Property Control

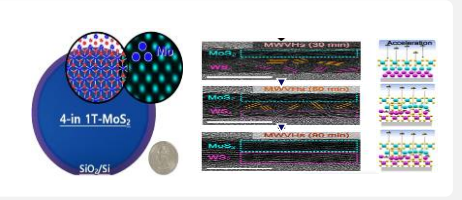
2-D Material Property Control Technology Through Plasma Characterization

01 Nano Control Technology for 2-D Materials



ChemSusChem (2021), 14, 1344.

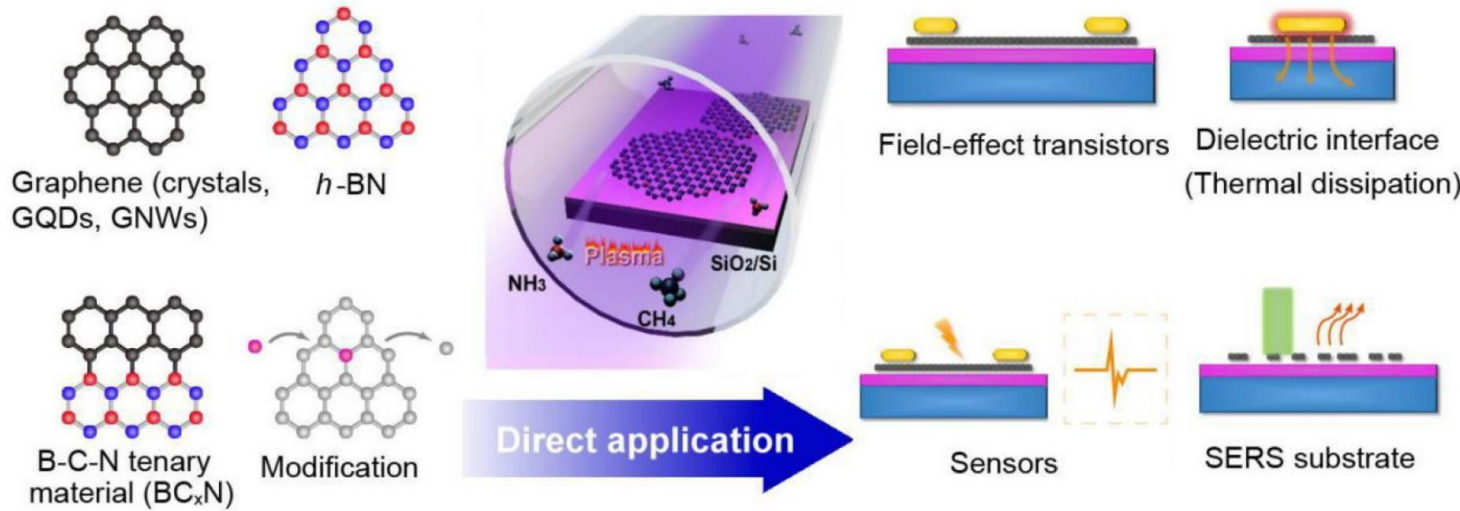
02 One-Step Heterointerface Synthesis



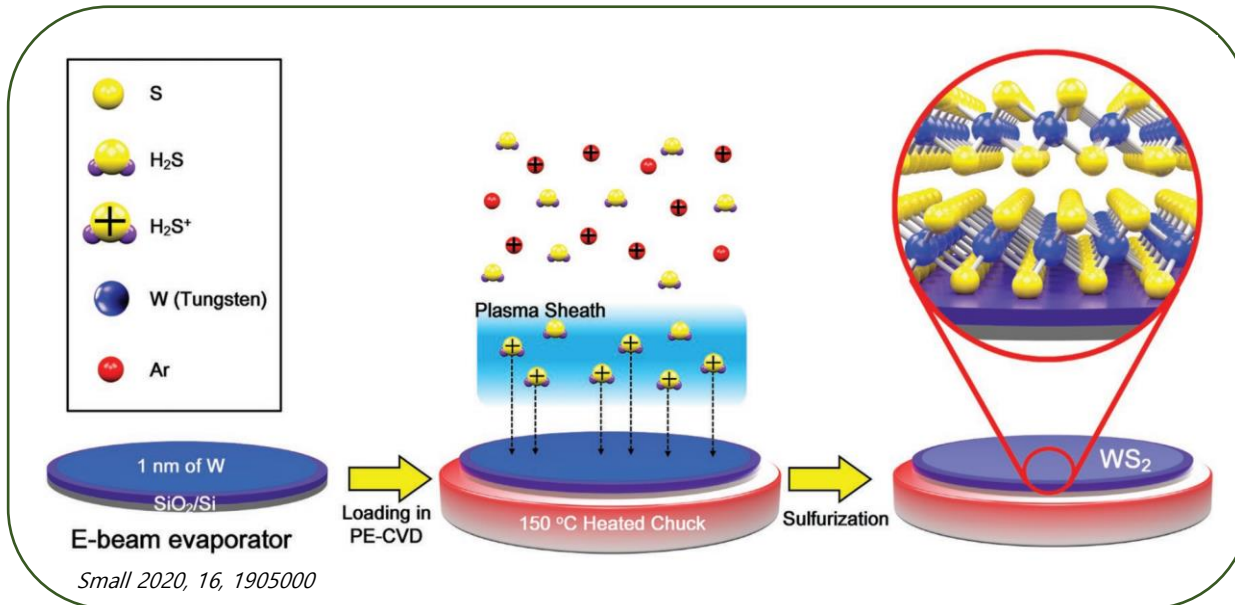
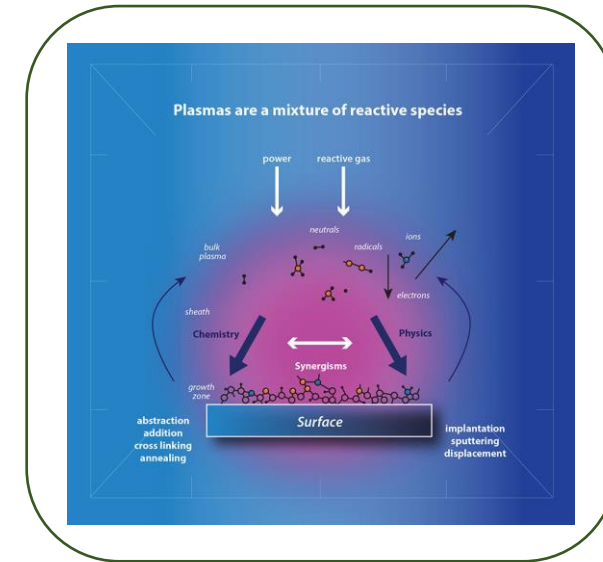
ACS Nano 2021, 15, 1, 707-718

- Enhanced Ion Mobility Based on Crystal Structure and Interfaces
- Simplified Process with Single Synthesis Technology

2-5. Advantages of Synthesizing 2D Materials using Low-Temperature Plasma Technology

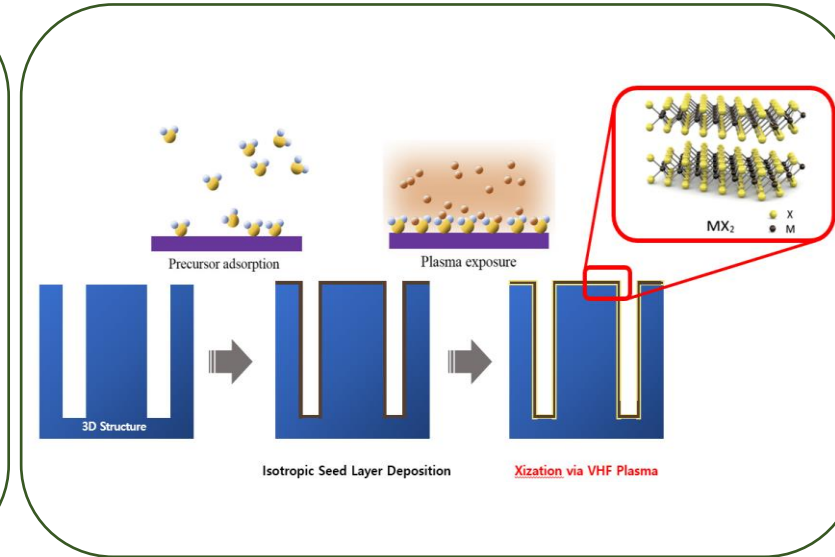
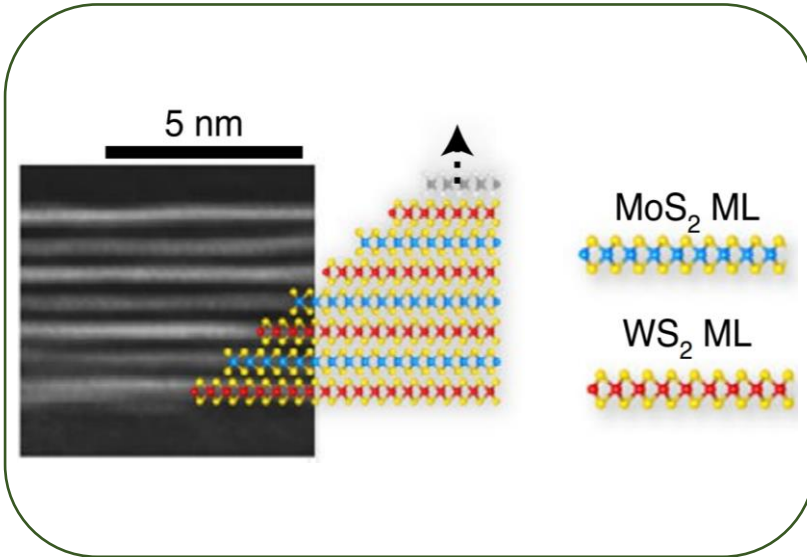


Yi, K., et al. *Accounts of Chemical Research* (2021) 4, 1011-1022

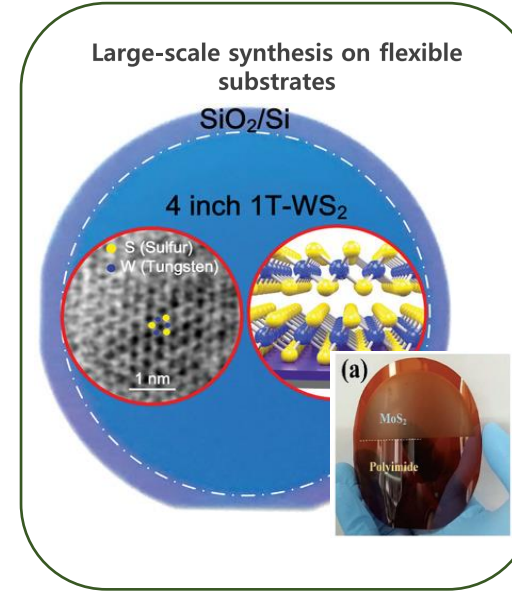
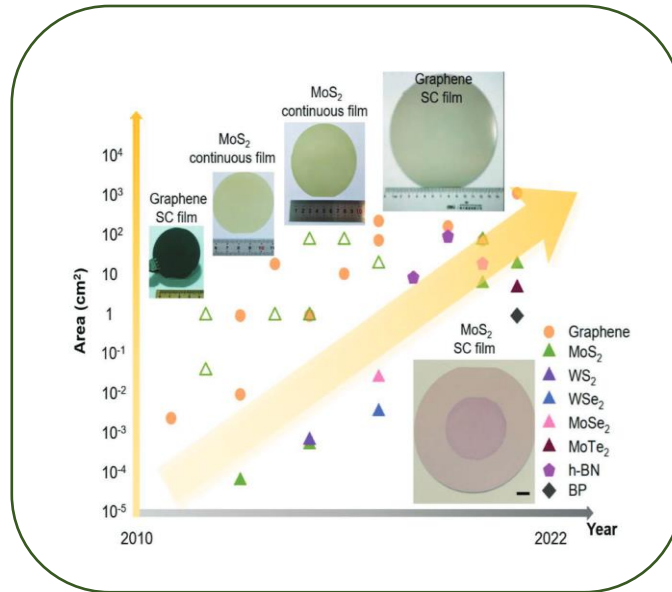
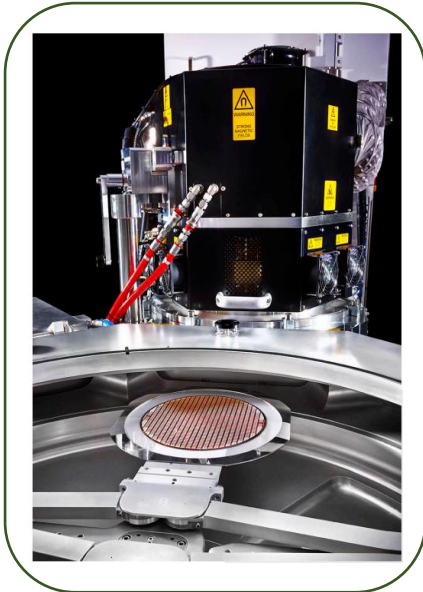


- By controlling various process variables, it is possible to synthesize 2D materials with desired characteristics
- The synthesis of large-area 2D materials enables the smooth fabrication of devices
- Synthesized by harnessing kinetic energy within the plasma field, it supplements the energy required for forming crystalline structures, enabling the synthesis of 2D materials even at low process temperatures (< 150 °C)

2-6. 2D Material Synthesis Technology via Low-Temperature Plasma



- For the synthesis of 2D materials, it is possible to utilize a plasma containing chalcogen elements. The transition metal(M) seed layer can be directly chalcogenized through the Xization process
- Efficient heterostructure synthesis technology can be achieved, surpassing conventional processes
- Even in three-dimensional curved areas, which were limitations of conventional synthesis methods, it is possible to deposit 2D materials
- Enhanced production capacity with large-area uniformity and reduced processing time
- The absence of a separate transfer process reduces process steps and increases production yield



Part 3. Electronic Applications – Tunneling Device

3-1. Need for Next Generation Devices

3-2. Next-Generation Device Application Based on 2D Materials

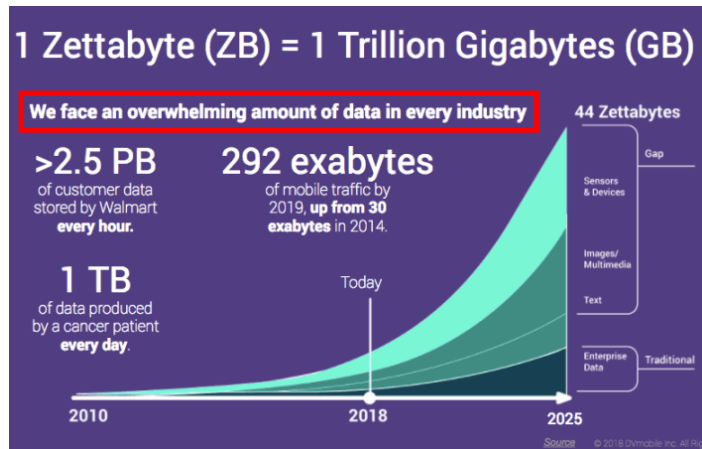
3-3. One-Step MoS₂-WS₂ Vertical HT Using Penetrative H₂S Plasma

3-4. Negative differential resistance (NDR) photodetector using MoS₂/p-Si HT

3-6. TMDC Layer Phase Transition via Process Temperature Control

3-7. Enhancement of the NDR Performance via Phase Transition

3-1. Need for Next Generation Devices

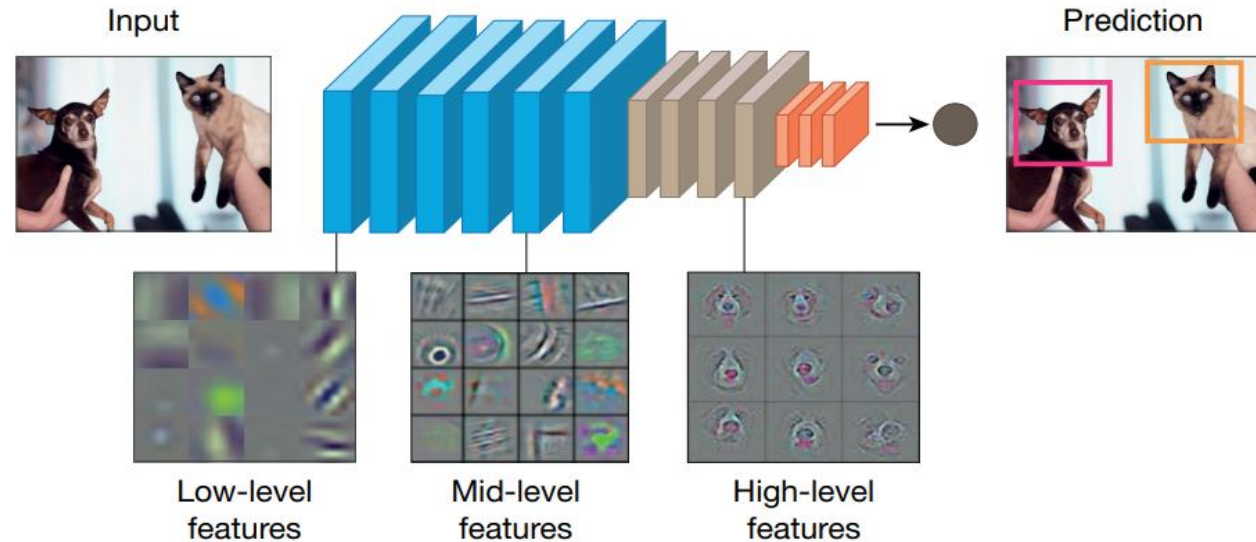
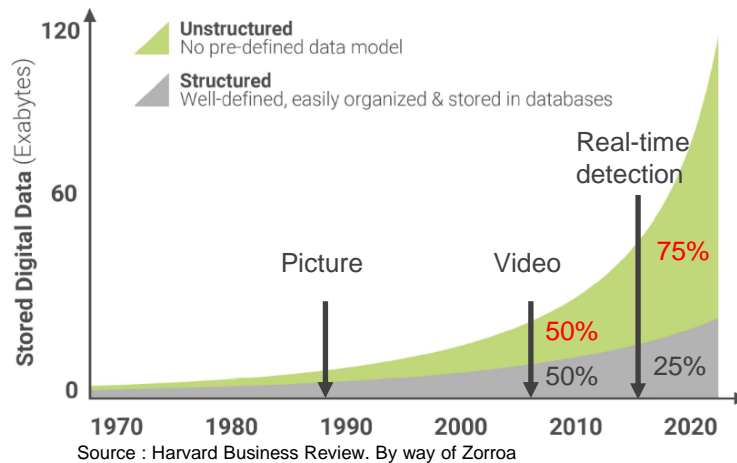


Source : <https://www.gregverdino.com/everything-is-exponential/>



Source : <http://www.newstof.com/news/articleView.html?idxno=1134>

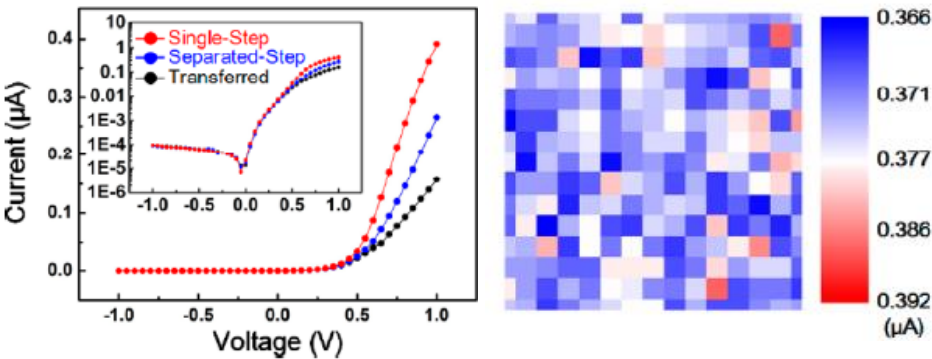
- With the development of AI, IoT, and industries, **the need for strong data processing means is emerging.**
- Two-dimensional materials are in the spotlight as core materials for next-generation devices due to **their excellent electrical properties and usability based on various band characteristics.**
- Research on **high-performance devices and high-density data storage devices** using two-dimensional materials is attracting a lot of attention



Source : Towards spike-based machine intelligence with neuromorphic computing

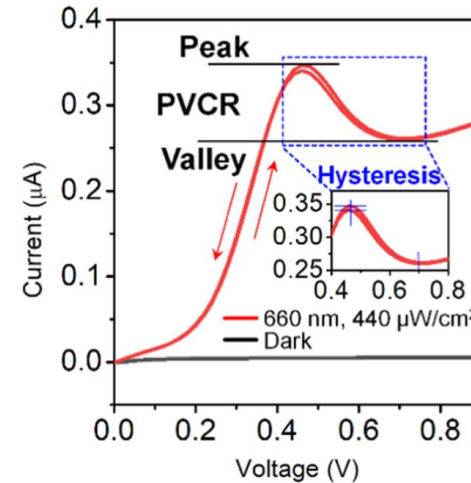
3-2. Next-Generation Device Application Based on 2D Materials

High Functional Optical Sensor



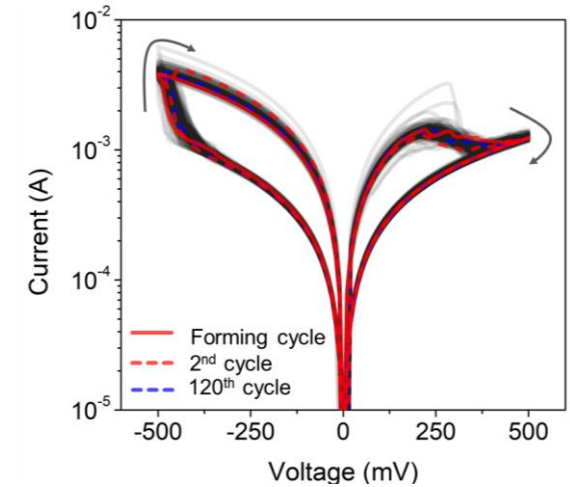
- **Principle of operation:** By inducing electron-hole separation through Type-II heterojunction using two-dimensional semiconductor materials, **excited photoelectrons are induced according to light irradiation**, thereby inducing photoreactivity
- **advantage:** Photoreactive Device with High Performance and Uniformity Based on Large Area Two-Dimensional Material Synthesis Technology Using PECVD

Negative Differential Resistance device (NDR device)



- **Principle of operation:** A phenomenon in **which negative differential range** appears in a specific voltage region due to tunneling in type-III heterojunction
- **advantage:** High functional devices can be manufactured through selective NDR phenomenon control depending on light irradiation.

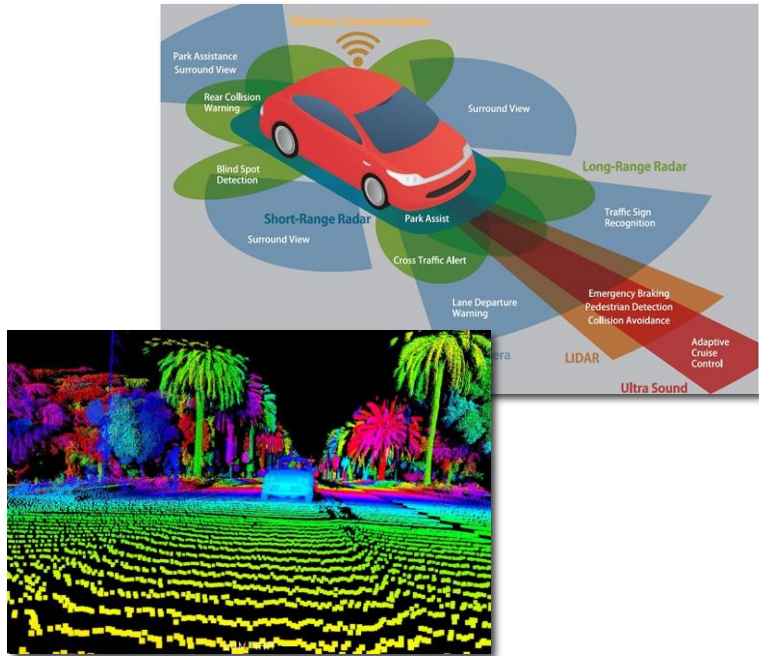
Memristor



- **Principle of operation:** By utilizing a highly scalable electrode material, **conductive filaments are formed inside the channel according to the applied voltage**. Memory state changes depending on whether filaments are formed.
- **advantage:** Two-terminal device-based memory simplifies circuits and enables high integration of devices.

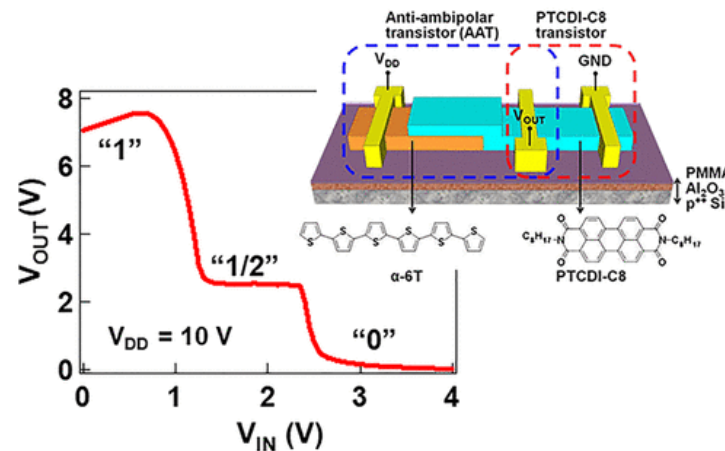
3-2. Next-Generation Device Application Based on 2D Materials

High Functional Optical Sensor



- **application:** Based on heterojunction property control, controls the detectable light area, Adjust the sensing point to be applied to LiDAR and infrared sensors

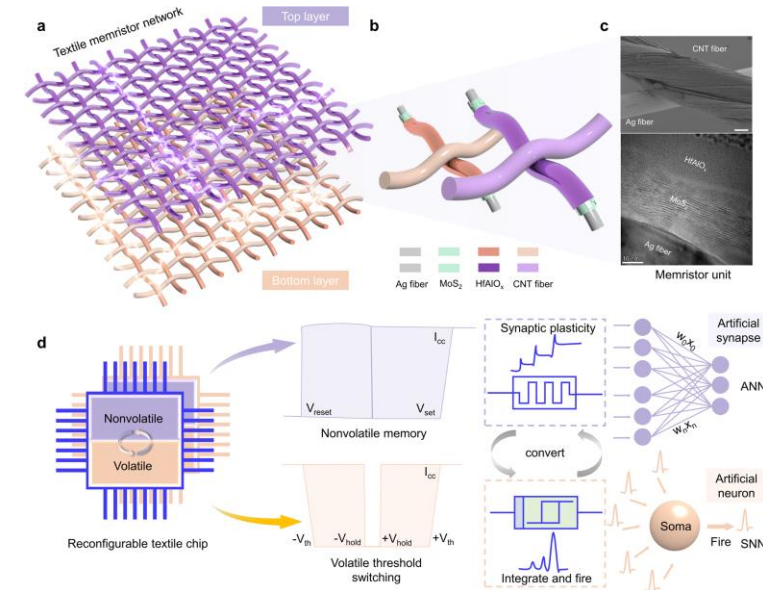
Negative Differential Resistance device (NDR device)



Nano Lett. 2018, 18, 7, 4355–4359

- **application:** Implementation of a multi-value logical system based on multi-threshold voltage characteristics. Deploy high-density data processing devices in simple circuits

Memristor

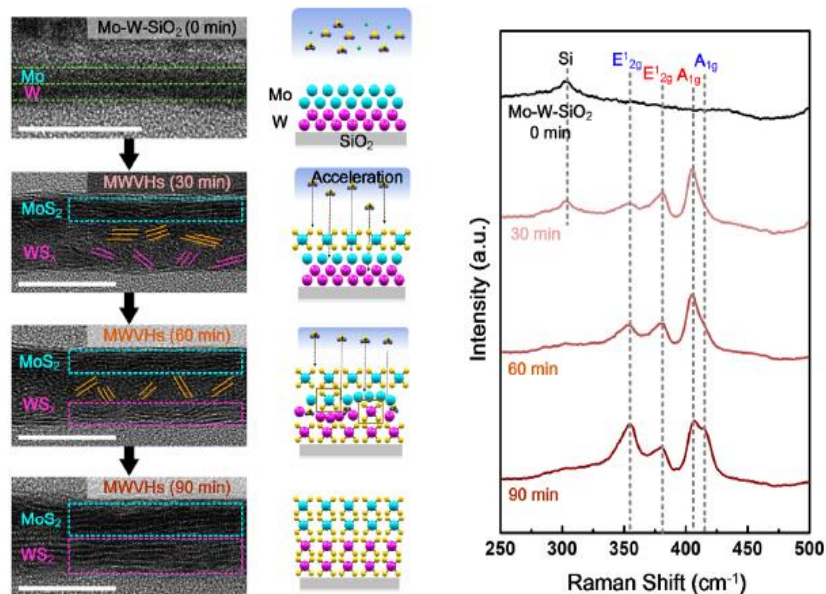


Nature Communications volume 13, Article number: 7432 (2022)

- **application:** Application in the study of neural simulation systems that simulate information transmission processes in the brain based on continuous data state changes.

3-3. One-Step MoS₂-WS₂ Vertical HT Using Penetrative H₂S Plasma

Single step heterojunction synthesis



ACS Nano 2021, 15, 707-718

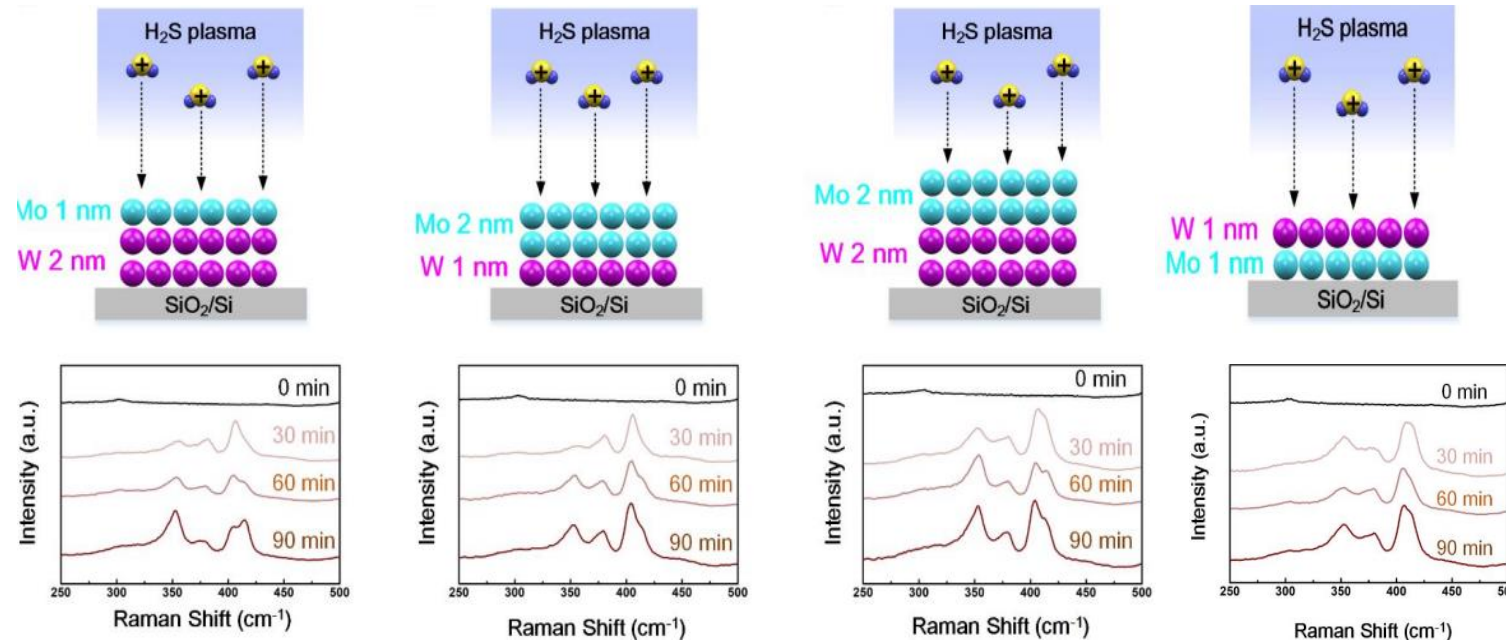
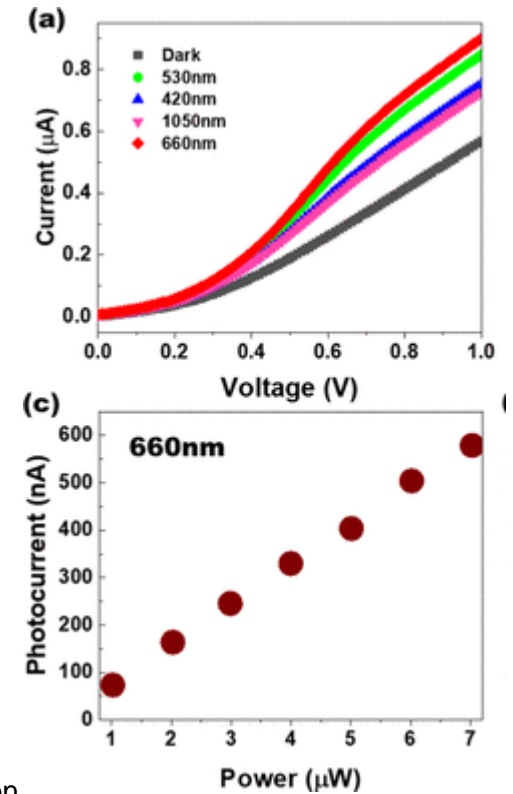
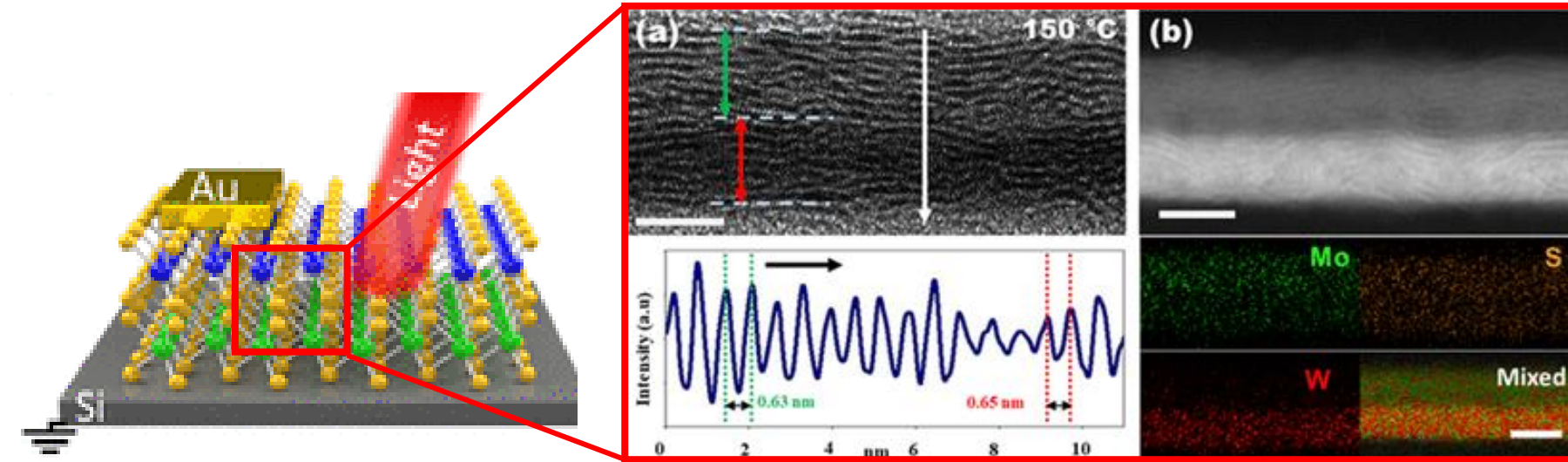


Figure. Time-dependent HR-TEM images, their schematic, Raman spectra.

Figure. Time-dependent Raman spectra along to different thickness and order of metal layer

- H₂S⁺ ions travel to the **Mo-W** metal layer by an electric field, penetrating from top to bottom.(ion penetration)
- The Top **Mo** layer is converted to **MoS₂**, and the Bottom **W** layer is converted to **WS₂**.
- Raman results reflect the position and thickness of the synthesized MoS₂ and WS₂ layers.

3-3. One-Step MoS₂-WS₂ Vertical HT Using Penetrative H₂S Plasma

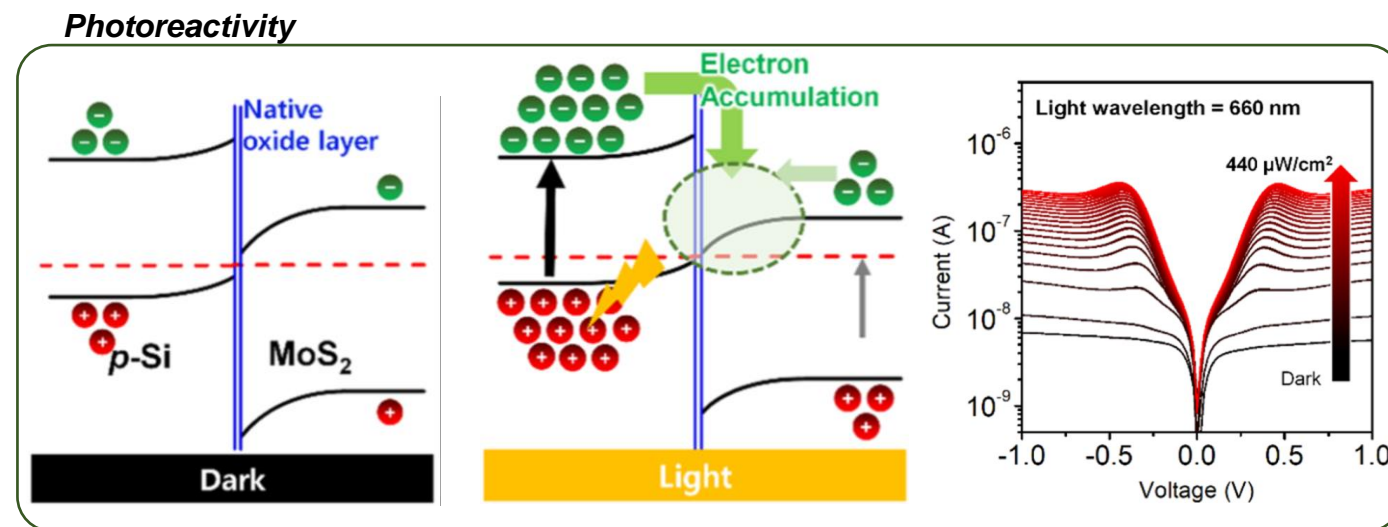
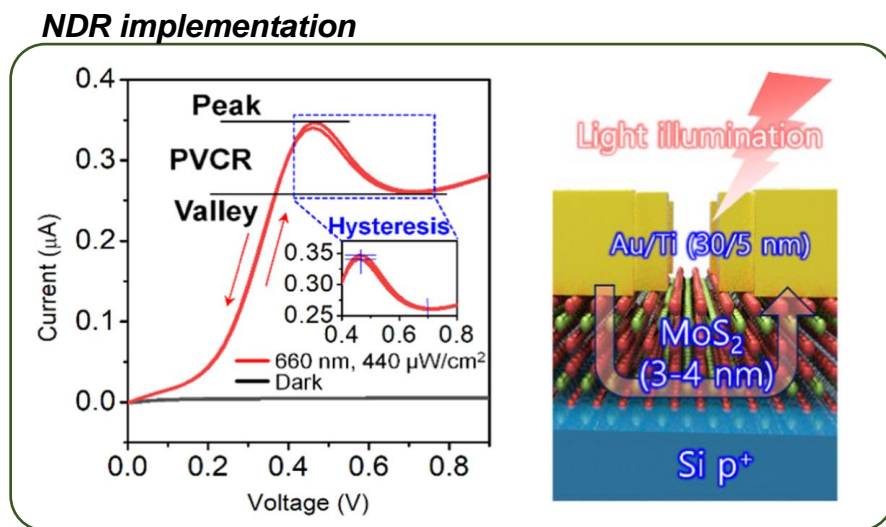


ACS Appl. Mater. Interfaces 2021, 13, 7, 8710–8717

Figure. Cross-sectional and in-plane HR-TEM images with EDS mapping of MWVHs and wafer-scale diode fabrication

- **MoS₂ (Top) and WS₂ (Bottom)** were synthesized with a uniform thickness of 5 layers each, and the spacing of the film was uniform at 0.63/0.65 nm
- The manufactured optical sensor showed photo reactivity of 83.75 mA/W and power consumption of 6μW.

3-4. Negative differential resistance (NDR) photodetector using MoS₂/p-Si HT



- **Fabrication:** Deposition of **2H-MoS₂** layer using PECVD process on p-Si substrate through **water transfer process**
- **Mechanism:** **Under light irradiation**, photo-excited electrons from the Si wafer are accumulated in the conduction band to bend the band structure. **The photogating effect** enhances tunneling between each band from MoS₂ to a p-Si substrate.
- **Operation:** During the main **charge transportation change** from Tunneling to Thermionic current, **NDR characteristics** appear.

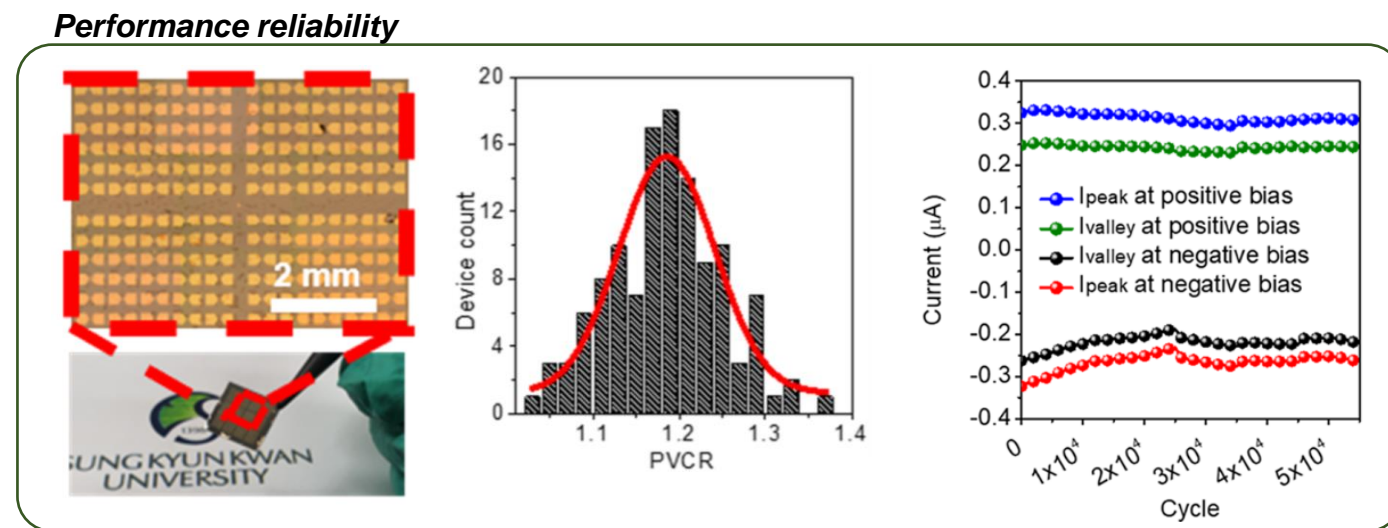


Figure. Mechanism and electrical characteristic of MoS₂/p-Si heterostructure

3-5. TMDC Layer Phase Transition via Process Temperature Control

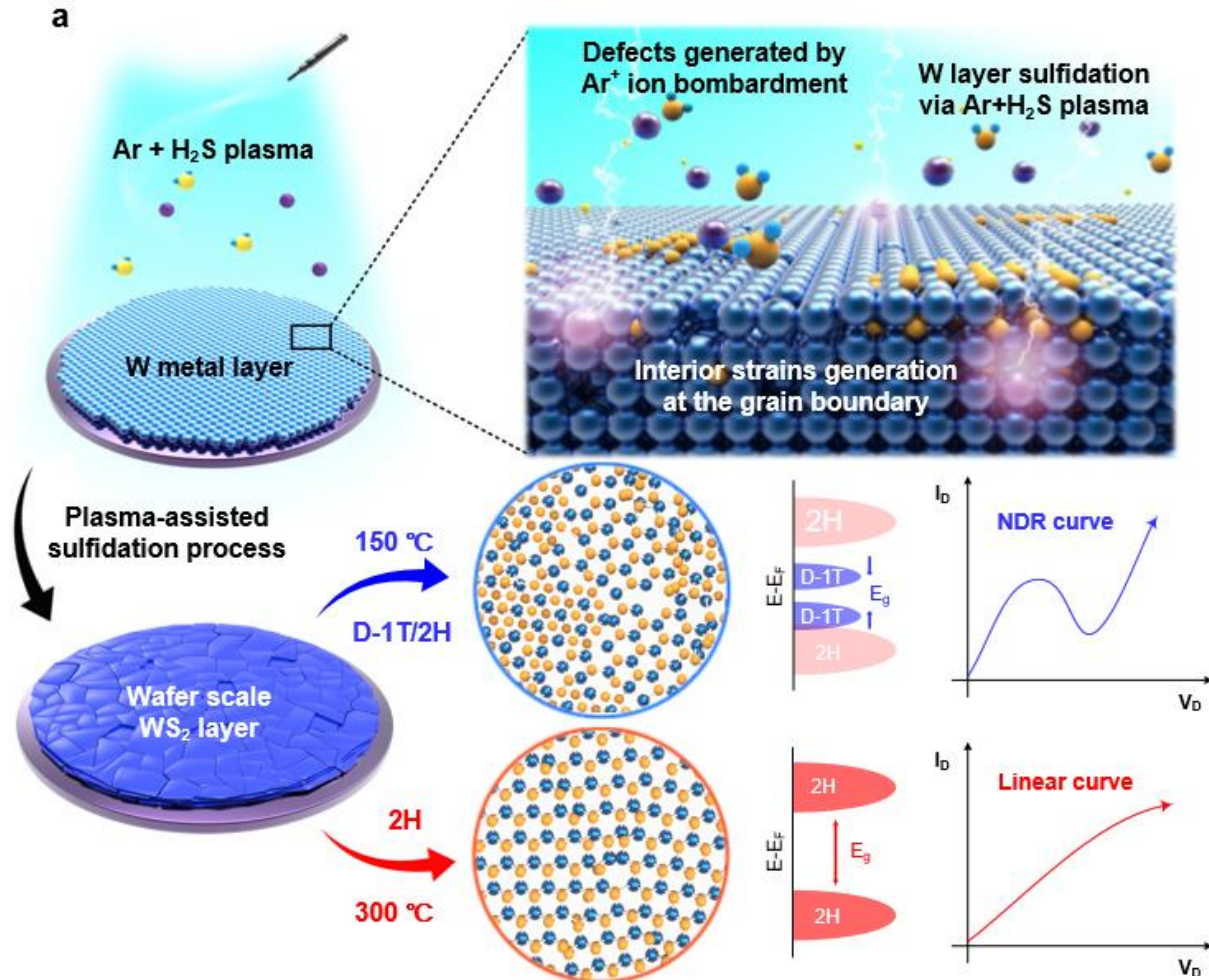


Figure. Temperature-dependent phase modulation process

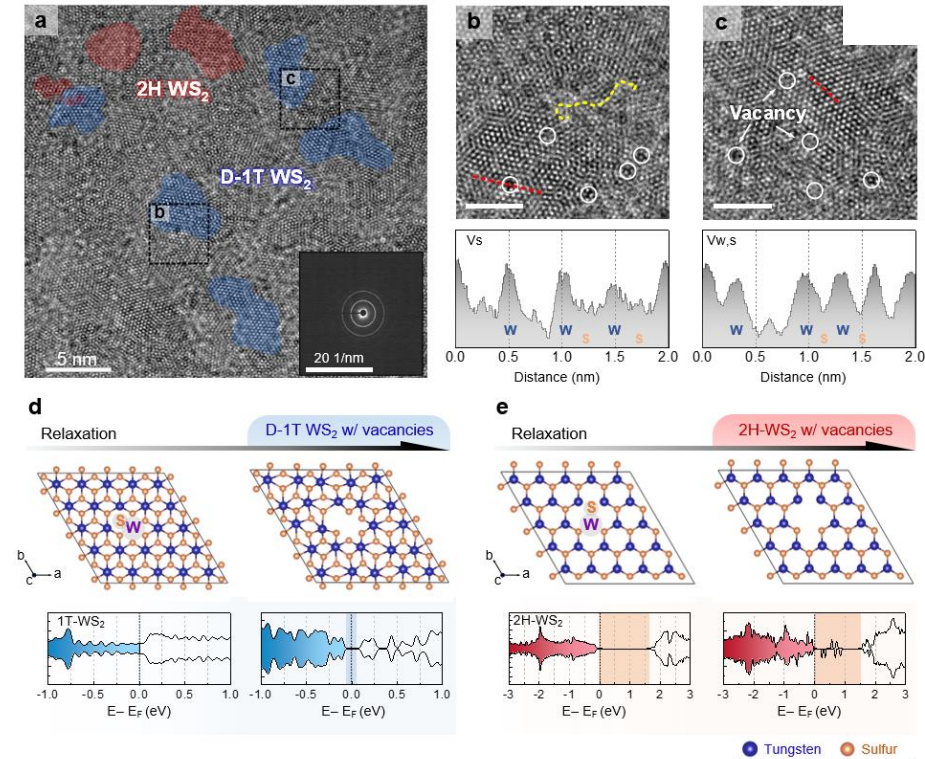


Figure. Calculation of the material characteristics of the defect accompanied D-1T/2H WS₂

- low-temperature sulfidation process → WS₂ layer 2H phase → Distorted 1T phase change.
(Cause → Internal stress and defects)
- By controlling the TMDC phase, it is possible to control electrical properties between semiconductors and semi-metals.

3-6. Enhancement of the NDR Performance via Phase Transition

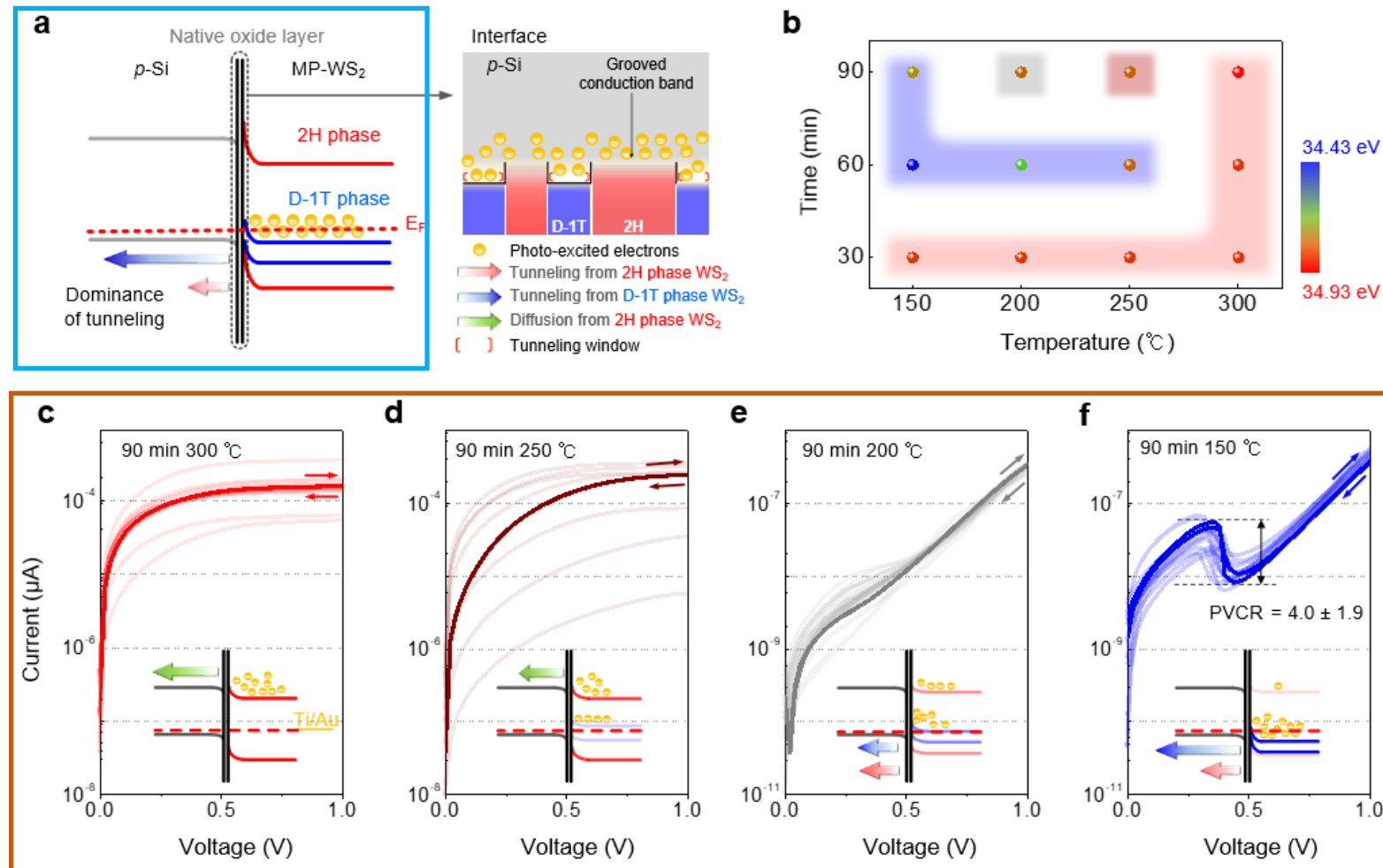


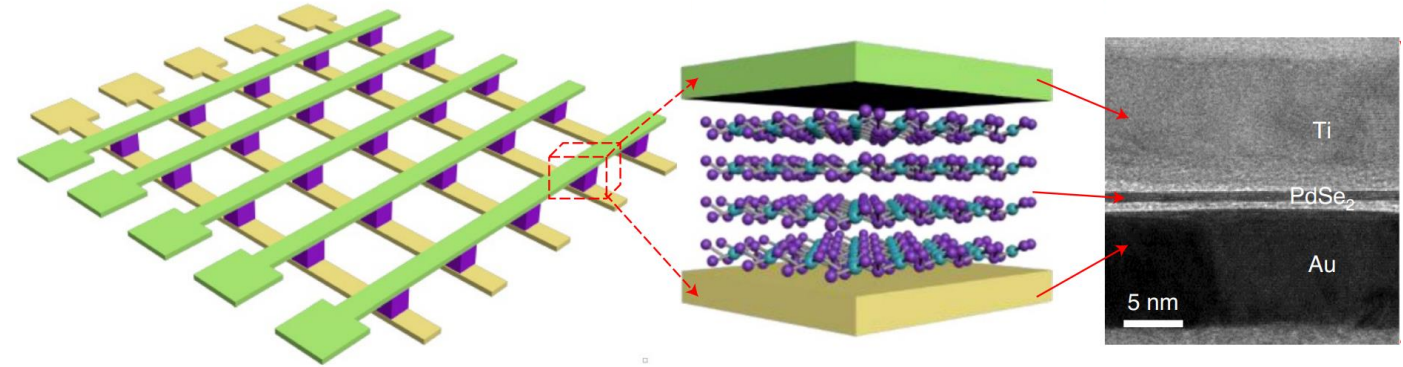
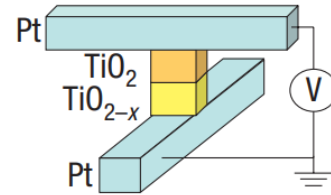
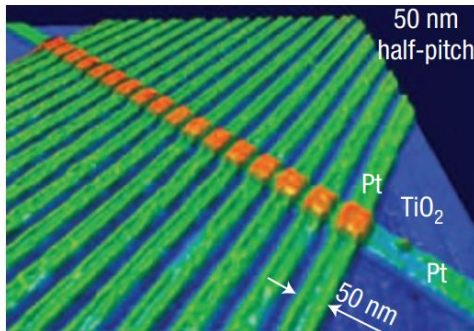
Figure. Mechanism analysis and optimization of the MP-WS₂/p-Si heterostructure.

- According to process temperature decrease, distorted 1T phase WS₂, **which shows semi-metallic characteristics**, is increased.
- Distorted 1T phase WS₂ expands the **tunneling window** between and WS₂ and Si substrates.
- **Photon-Electron Accumulation at Interface layer by Illumination**
→ Promote **electron tunneling** throughout the window.
- The proposed NDR device is applied to the photoreactive-RAM application based on the resistive bi-stability.

Part 4. Electronic Applications – Neuromorphic Device

- 4-1. Mechanism of Neuromorphic Device
- 4-2. 2D Materials for Neuromorphic Applications
- 4-3. Grain Confinement via Low-temperature Synthesis
- 4-4. Nanograin Memristor
- 4-5. Grain Boundary Effect in Neuromorphic Performance Reliability
- 4-6. Patents

4-1. Mechanism of Neuromorphic Device

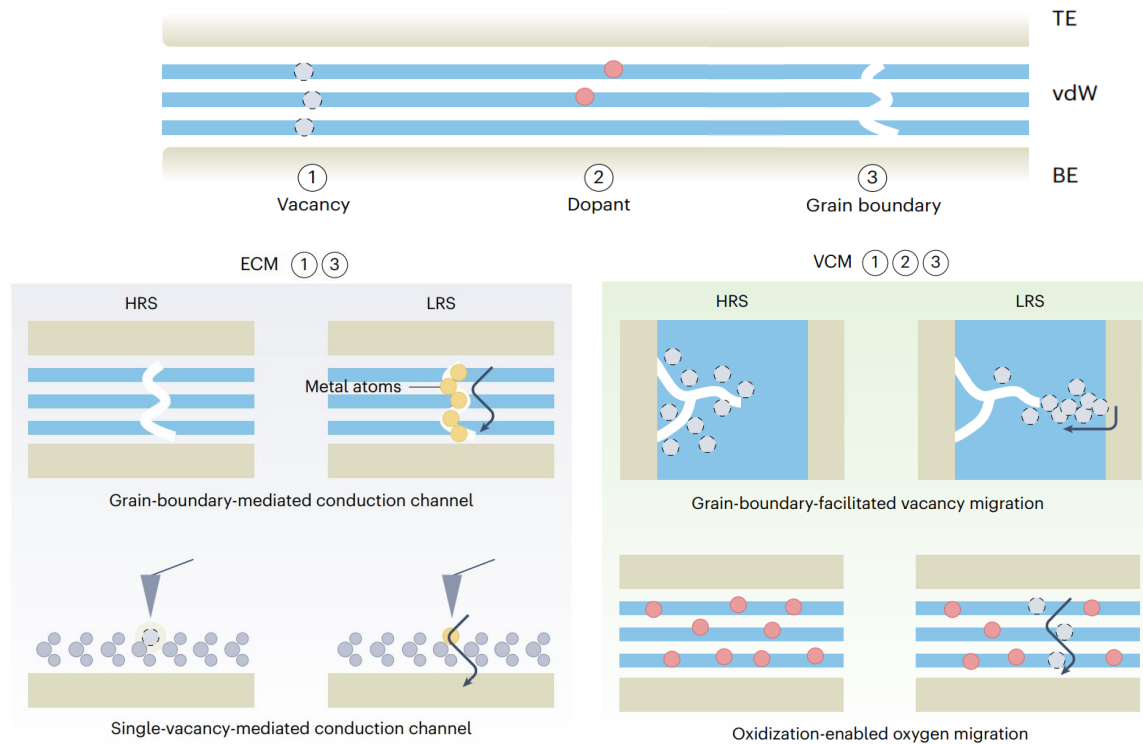


Yang, J., et al. *Nat. Nanotech.*, 2008, 3: 429–433.

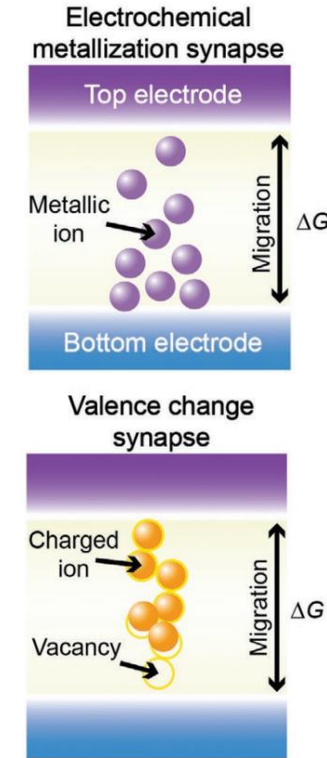
Li, Y., et al. *Nature electronics*, 2021, 4: 348–356.

- Early memristors were made of metal-oxide-based oxide materials, but as the size of the device scaled down, it became a problem to stabilize the uniform resistive switching of the device.
- In addition, as the area and thickness of the metal-oxide-based oxide material decreases, excessive filament formation occurs, which worsens the reliability of resistive switching.
- As an alternative, the use of van der Waals structured materials to provide atomic-level uniformity while simultaneously having a low electron density of states is gaining attention for low-power resistive switching at the nanoampere level or below.
- An additional hot topic of research is to utilize the feature that all surfaces are geometrically uniform, so that various defects can be given to form filaments wherever desired.

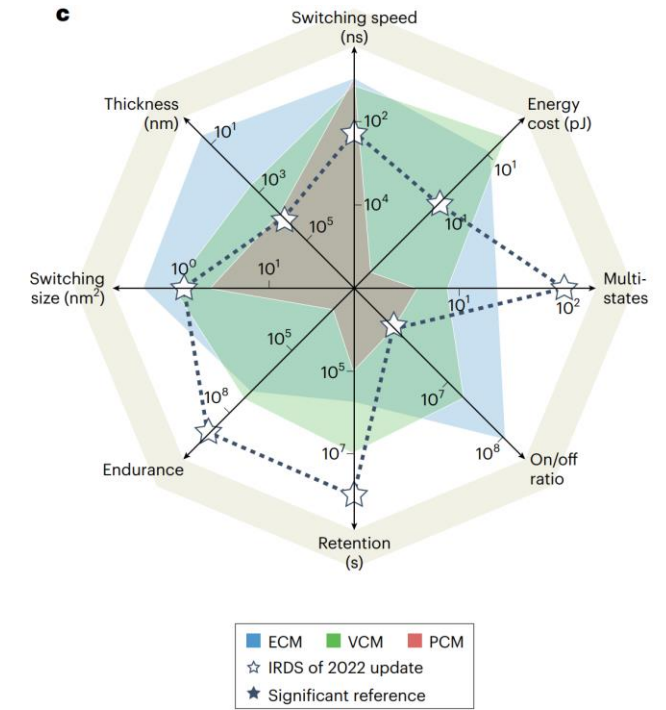
4-2. Mechanism of Neuromorphic Device



Kang, J.H., et al. *Nature electronics*, 2023, 6: 491–505.



Choi, S., et al. *Adv. Mater.* (2020) 32, 2204659.



Huh, W., et al. *Advanced Materials* (2020) 32, 2002092

- Filament-based resistive switching devices can be broadly categorized into VCM and ECM according to their operating principles.
 - VCMs: resistive switching occurs only with internal conduction channel materials without the intervention of external materials when a voltage is applied to the electrode
 - ECMs: conduction channel materials from the outside enter and cause resistive switching depending on the voltage applied to the electrode.
- VCM-based devices have the advantage of high stability and reliability because the operation is performed only internally, unlike ECMs, which are artificially pierced by external materials.
- On the other hand, ECM-based devices have the advantage of having a lower threshold voltage than VCM, which requires overall movement inside the device because filaments are formed by migration of external metal atoms.

4-3. Generation of Nanograin Based on Low Process Temperature

Formation of nanograin TMDC materials via PECVD sulfidation

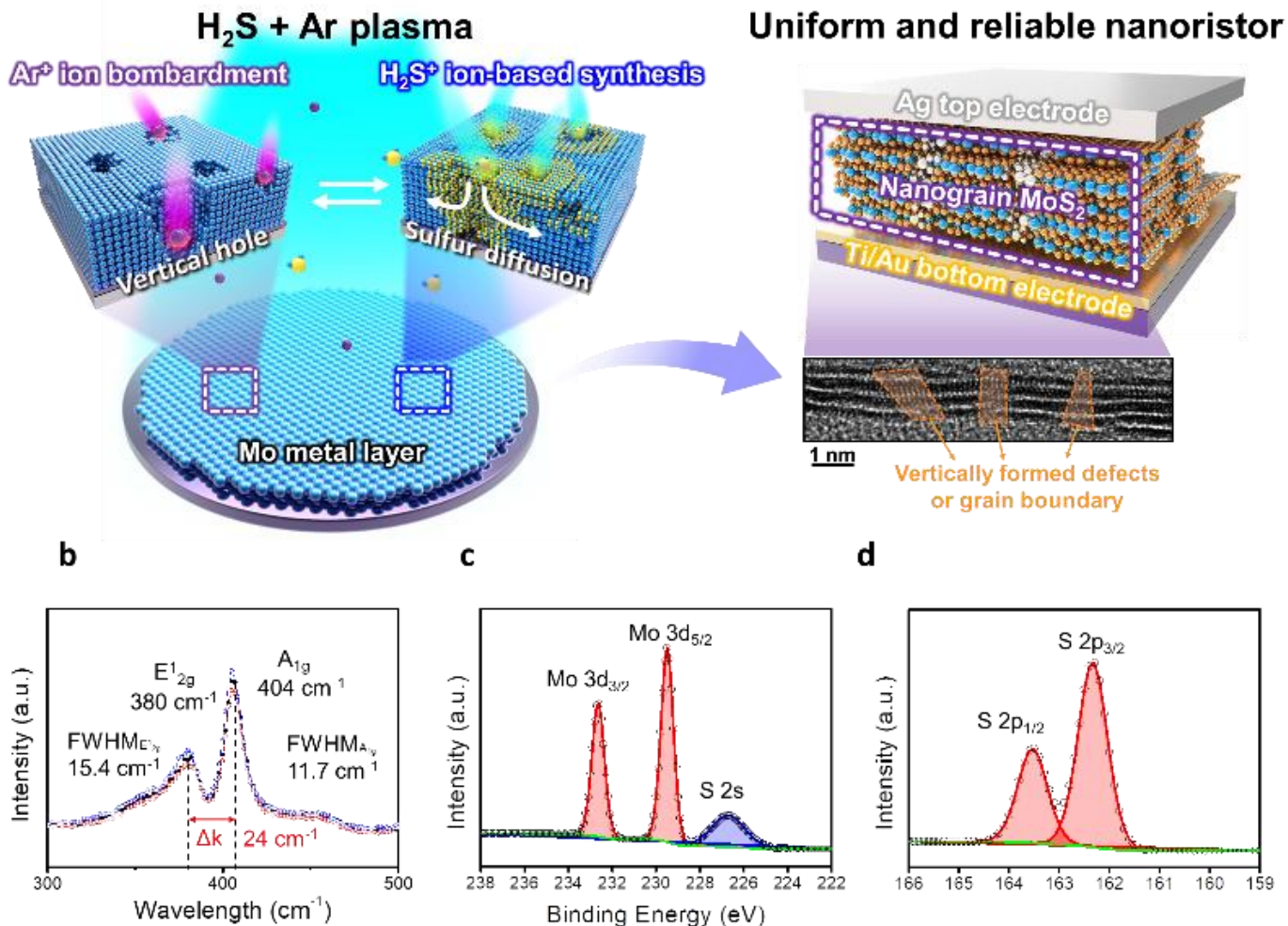


Figure. Schematic of nanograin MoS₂ synthesis process

- During plasma treatment, **H₂S ion penetrate the Mo layer, diffused into the layer.**
- Numerous nuclei** make the grain hard to grow with large size over 10 nm.
- Because of the uniform metal layer thickness, the MoS₂ can be prepared with **uniform thickness of 5 nm**

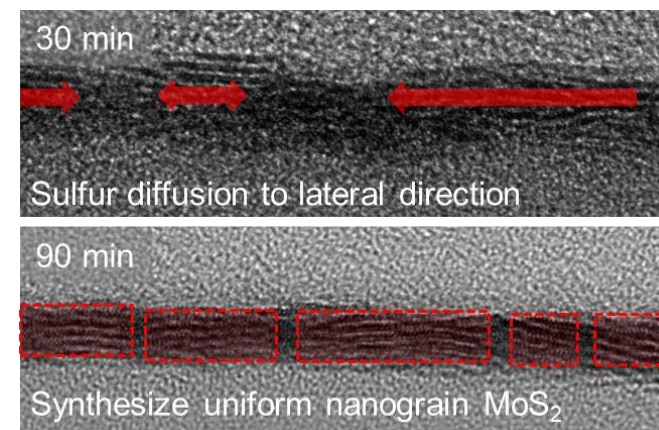


Figure. Synthesized MoS₂ depending on process time

4-3. Generation of Nanograin Based on Low Process Temperature

Formation of nanograin TMDC materials via PECVD sulfidation

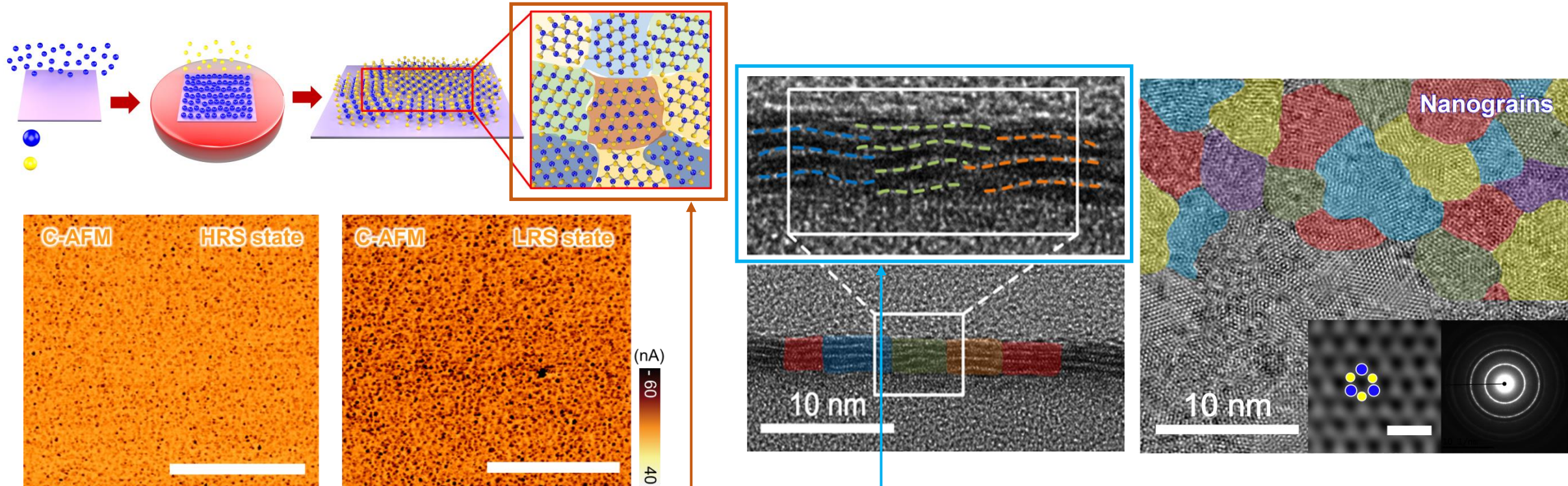


Figure. C-AFM current map of the MoS₂ nanograins layer

Figure. In-plane HRTEM image with color marked nanosize of grain

- The grain size is formed **within a size of 10 nm** by a low synthesis temperature.
- The generated **grain boundary** may serve as **a guideline** for diffusible metal electrode ions.
- TEM images and C-AFM results represent the effect of guidelines on the presence of small grain sizes and ion migration.

4-4. Memristor Application Using Nanograin TMDC Materials

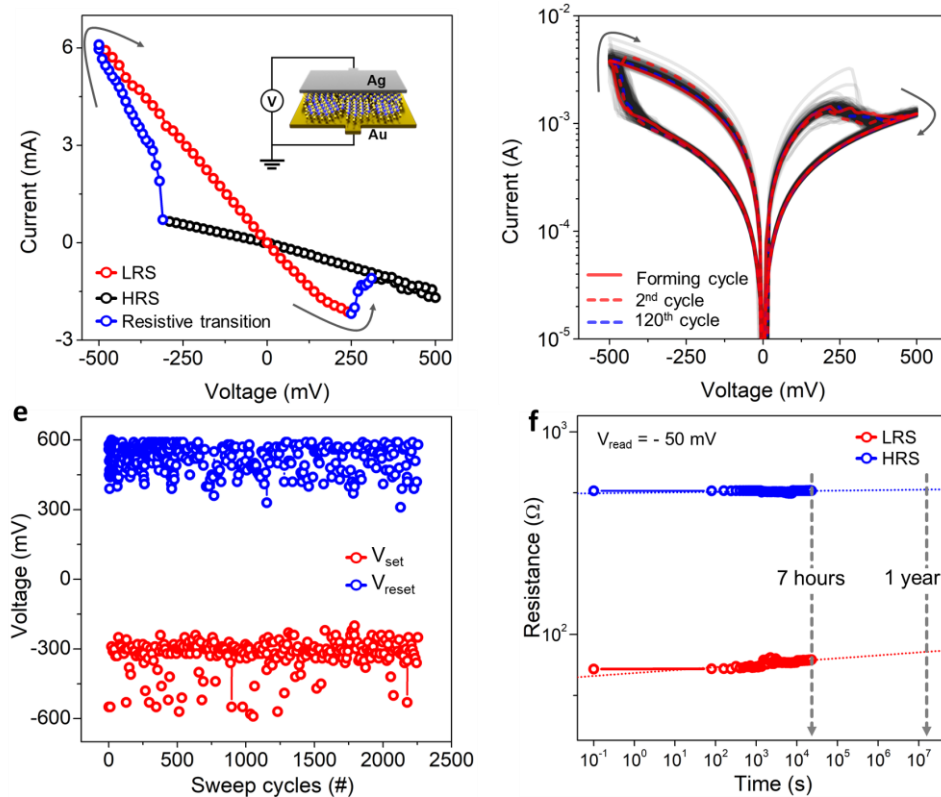


Figure. Performance of nanograin MoS₂ memristor

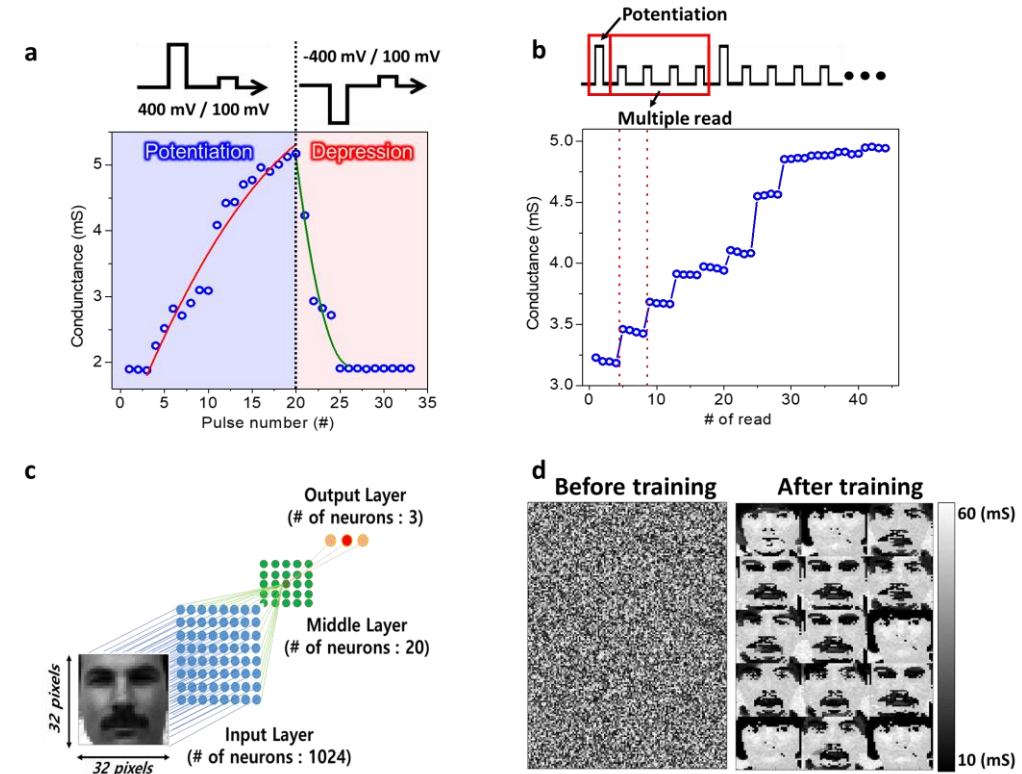


Figure. Potentiation-depression characteristics of the MoS₂ nanoristor.

- Grain boundary makes it easier for metal electrode ions to move along the applied electric field.
- This creates a **forming-free memristor device** so that memory performance does not change during durability tests.
- The manufactured memristor device is applied to **electronic synapse device applications** and shows great viability as SNN.

- ✓ Plasma assisted metal layer sulfurization method is one of the most promising method to achieve **highly uniform/reliable/reproducible production process for wafer-scale TMDCs materials.**
- ✓ We have successfully implemented **homostructured/heterostructured TMDCs** layer and observed **temperature-dependence phase tunability** from 2H to 1T phase or vice versa.
- ✓ The intrinsic semiconductive/semi-metallic characteristic of the PECVD grown TMDCs layers are feasible to fabricate functional electronic device with **superior photo-reactivity and unique NDR characteristics**
- ✓ A nanograined TMDCs layer serves as a **resilient pathway for metal-ion transport**, bolstering the reliability and uniformity of memristor and synaptic applications



- **Project:** 차세대 이차원 소재 상용화를 위한 플라즈마 공정 최적화 (리더연구)
- **Period:** 2022.06.01 ~ 2031.02.28
- **Support:** National Research Foundation of Korea



- **Project:** 수전해 전극 공정을 위한 저온 플라즈마 기초연구실 (BRL)
- **Period:** 2022.06.01 ~ 2025.02.28
- **Support:** National Research Foundation of Korea



- **Project:** 플라즈마 공정 최적화 프로세스를 활용한 이차원 소재 합성 및 뉴로모픽 소자개발 연구
- **Period:** 2020.09.16 ~ 2025.09.15
- **Support:** Samsung electronics



- **Project:** In-situ 결합분석을 통한 고품위 MX2 소재 및 공정기술 개발 (반도체고급인력양성사업)
- **Period:** 2023.04.01 ~ 2027.12.31
- **Support:** Korea Evaluation Institute of Industrial Technology

2024 KOR-EU Joint Workshop

Q&A

Taesung Kim

School of Mechanical Engineering and SAINT
Department of Semiconductor Convergence Engineering
Sungkyunkwan University (SKKU)